Docket No.

248402US99DIV

TES PATENT AND TRADEMARK OFFICE IN THE UN

IN RE APPLICATION OF:

Jamal RAMDANI, et al.

SERIAL NO: 10/767,994

GAU:

2815

FILED:

February 2, 2004

EXAMINER: BAUMEISTER

FOR:

SEMICONDUCTOR STRUCTURE, SEMICONDUCTOR DEVICE, COMMUNICATING DEVICE,

INTEGRATED CIRCUIT, AND PROCESS FOR FABRICATING THE SAME

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, and copies were submitted in Application Serial No. 09/808,888 according to the attached copy of a Granted Petition. This application contains related subject matter.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.
- ☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

10/26/2004 EAREGAY1 00000046 10767994

02 FC:1806

180.00 OP

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,

MAIER & NEUSTADT, P.C.

Richard L. Treanor

Registration No. 36,379

Customer Number

Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 05/03)

OCT 2 5 2004

SHEET 1 OF 23

Form PTO 1449 (Modified)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

OCT 2.5 ZUUA ET NO. 248402US99DKVR40ENAS APPLICANT

10/767,994

LIST OF REFERENCES CITED BY APPLICANT

Jamai RAMDANI, et al.

SERIAL NO.

| | | | | FILING DATE | TIGIT TO AND AIN | GROUP | |
|---------------------|----|--------------------|---------------------------------------|---------------------------------------|------------------|----------------|---------------|
| | | | | February 2, 2004 | l | | 2815 |
| EVALUED | _ | | · · · · · · · · · · · · · · · · · · · | U.S. PATENT DOCUMENTS | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB | FILING DATE |
| | AA | 3,802,967 | 04/09/74 | Ladany et al. | | CLASS | IF APPROPRIAT |
| - | AB | 4,174,422 | 11/13/79 | Matthews et al. | | - | |
| | AC | 4,404,265 | 09/13/83 | Manasevit | | | |
| | AD | 4,482,906 | 11/13/84 | Hovel et al. | | | |
| | ΑE | 4,523,211 | 06/11/85 | Morimoto et al. | | | |
| | AF | 4,661,176 | 04/28/87 | Manasevit | | | |
| | AG | 4,793,872 | 12/27/88 | Meunier et al. | | | |
| | ÄH | 4,846,926 | 07/11/89 | Kay et al. | | | |
| | AJ | 4,855,249 | 08/08/89 | Akasaki et al. | | | |
| | AI | 4,891,091 | 01/02/90 | Shastry | | | |
| | ĀK | 4,912,087 | 03/27/90 | Aslam et al. | | | |
| | AL | 4,928,154 | 05/22/90 | Umeno et al. | | | |
| | AM | 4,963,949 | 10/16/90 | Wanlass et al. | | | |
| | AN | 5,141,894 | 08/25/92 | Bisaro et al. | | | |
| | 40 | 5,159,413 | 10/27/92 | Calviello et al. | | | |
| | AΡ | 5,173,474 | 12/22/92 | Conneil et al. | | | |
| | \Q | 5,221,367 | 06/22/93 | Chisholm et al. | | | |
| | ĀR | 5,225,031 | 07/06/93 | McKee et al. | | | |
| | \S | 5,358,925 | 10/25/94 | Neville Connell et al. | | | |
| | \T | 5,393,352 | 02/28/95 | Summerfelt | _ _ | | · |
| | Ū | 5,418,216 | 05/23/95 | Fork | | | |
| | V | 5,450,812 | 09/19/95 | McKee et al. | | | |
| | | 5,478,653 | 12/26/95 | Guenzer | | | |
| A | x | 5,482,003 | 01/09/96 | McKee et al. | | | |
| A | Y | 5,514,484 | 05/07/96 | Nashimoto | _ | | |
| — | | 5,556,463 | 09/17/96 | Guenzer | | | |
| B | | 5,588,995 | 12/31/96 | Sheldon | | | |
| BI | | 5,670,798 | 09/23/97 | Schetzina | | | |
| В | | 5,733,641 | 03/31/98 | Fork et al. | | | |
| В | | 5,735,949 | 04/07/98 | Manti et al. | | | |
| BE | | 5,741,724 | 04/21/98 | Ramdani et al. | | | |
| В | | 5,810,923 | 09/22/98 | Yano et al. | | | |
| ВС | | 5,830,270 | 11/03/98 | McKee et al. | | | |
| B⊦ | | 5,912,068 | 06/15/99 | Jia | | | |
| ВІ | | 6,020,222 | | Wollesen | | | |
| BJ | | 6,045,626 | 04/04/00 | Yano et al. | | | |
| ВК | | 5,064,078 | | · · · · · · · · · · · · · · · · · · · | | | |
| BL | | 6,064,092 | | Northrup et al. Park | | | |
| BM | | 6,096,584 | | | | | |
| BN | | 5,103,008 | i | Ellis-Monaghan et al. | | | |
| ВО | | ,136,666 | _ _ _ | McKee et al. So | | | |
| BP | | ,174,755 | | | | | |
| BQ | | ,180,486 | | Manning | | | |
| | | , . | 01/30/01 | eobandung et al. | | 7 | |

| Form PTO 1449 | - | U.S. DEPARTMENT OF CO | NAME DOE | | | | HEET 2 | OF 23 |
|------------------|---------------------------------------|------------------------|-----------|--------------------------------|--|-------------------|------------------|---------|
| (Modified) | | PATENT AND TRADEMARK O | PFFICE | ATTY DOCKET NO. 248402US99DIV | | SERIAL | NO. 10/767,99 | 94 |
| LIST OF | LIST OF REFERENCES CITED BY APPLICANT | | APPLICANT | | | | | |
| | | | | FILING DATE | I RAMDANI | , et al. GROUP | | |
| | | | | February 2, 2004 | | J Gridon | 2815 | |
| | | | | U.S. PATENT DOCUMENTS | | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB | FILING | DATE |
| | CA | 3,766,370 | 10/16/73 | Walther | | CLASS | IF APPR | OPRIATE |
| | СВ | 4,006,989 | 02/08/77 | Andringa | | | | |
| | cc | 4,284,329 | 08/18/81 | Smith et al. | | | | |
| | CD | 4,777,613 | 10/11/98 | Shahan et al. | | | | |
| | CE | 4,802,182 | 01/31/89 | Thornton et al. | | | | |
| | CF | 4,882,300 | 11/21/89 | Inoue et al. | | | | |
| | CG | 4,896,194 | 01/23/90 | Suzuki | | - | | |
| | CH | 4,999,842 | 03/12/91 | Huang et al. | | | | |
| | CI . | 5,081,062 | 01/14/92 | Vasudev et al. | | | | |
| C | יר ב | 5,155,658 | 10/13/92 | Inam et al. | | | | |
| C | K | 5,248,564 | 09/28/93 | Ramesh | | | | |
| C | L | 5,260,394 | 11/09/93 | Tazaki et al. | | | - | |
| | M | 5,270,298 | 12/14/93 | Ramesh | | | | |
| | N | 5,286,985 | 02/15/94 | Taddiken | | | | |
| | 0 | 5,310,707 | 05/10/94 | Oishi et al. | | | | |
| С | | 5,326,721 | 07/05/94 | Summerfelt | | | | |
| C | | 5,404,581 | 04/04/95 | Honjo | | | | |
| CI | | 5,418,389 | 05/23/95 | Watanabe | | | | |
| C: | | 5,436,759 | 07/25/95 | Dijaii et al. | | | | |
| С | | 5,576,879 | 11/19/96 | Nashimoto | | | | |
| Cl | | 5,606,184 | 02/25/97 | Abrokwah, et al. | | | | |
| C/ | | 5,640,267 | 06/17/97 | May et al. | | | | |
| CV | | 5,674,366 | 10/07/97 | Hayashi et al. | | | | |
| CX | | 5,729,641 | 03/17/98 | Chandonnet et al. | | | | |
| CY CZ | | 5,790,583 | 08/04/98 | Но | | | | |
| DA | | 5,825,799 5,857,049 | 10/20/98 | Ho et al. | | | | |
| DB | | 5,874,860 | 01/05/99 | Beranek et al. | | | | |
| DC | | 5,926,496 | 02/23/99 | Brunel et al. | | | | |
| DD | | 5,937,285 | 07/20/99 | Ho et al. | | | | |
| DE | | 5,981,400 | 08/10/99 | Abrokwah, et al. | | | | |
| DF | | 5,990,495 | 11/09/99 | Lo | | | | |
| DG | | 5,002,375 | 11/23/99 | Ohba | | | | |
| DH | | 5,008,762 | 12/14/99 | Corman et al. | | | | |
| DI | | 6,055,179 | 04/25/00 | Nghiem Koganai et al | | | | |
| DJ | | 6,107,653 | 08/22/00 | Koganei et al. Fitzgerald | | | | |
| DK | | 5,113,690 | 09/05/00 | Yu et al. | | | | |
| DL | | 6,114,996 | 09/05/00 | Nghiem | | | | |
| DM | | ,121,642 | 09/19/00 | Newns | | | | |
| DN | L | ,128,178 | | Newns | | | | |
| DO | | ,143,072 | | McKee et al. | | | | |
| DP | | | 02/06/01 | Lo | | | | |
| DQ | | | | Frigo | | | | |
| | | | | 9- | 1 1 | 1 | | |

| Form PTO 1449 U.S. DEPARTMENT OF COM (Modified) PATENT AND TRADEMARK OF | | COMMERCE K OFFICE | ATTY DOCKET NO. | | SERIA | SHEET 3 OF LNO. | | |
|---|----------|------------------------|---------------------------|----------------------------|------------|--------------------|----------------------------|--|
| | | | 248402US99DI APPLICANT | V | | 10/767,994 | | |
| LIST O | FREF | ERENCES CITED BY | Y APPLICANT | Ja | mal RAMDAN | Ⅱ, et al. | | |
| | | | | FILING DATE | | GROUI | | |
| | | | | February 2, 200 |)4 | | 2815 | |
| EXAMINER | T- | DOCUMENT | DATE | U.S. PATENT DOCUMENTS NAME | | | | |
| NITIAL | F- A | NUMBER | | | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE | |
| | EA | 4,484,332 | 11/20/84 | Hawrylo | | 1 | ATTROFTIALE | |
| | EB | 4,815,084 | 03/21/89 | Scifres et al. | | <u> </u> | | |
| | EC | 4,876,219 | 10/24/89 | Eshita et al. | | <u> </u> | | |
| · | ED | 4,963,508 | 10/16/90 | Umeno et al. | | | | |
| | EE | 5,060,031 | 10/22/91 | Abrokwah, et al. | | | | |
| | EF | 5,063,166 | 11/05/91 | Mooney et al. | | | | |
| | EG | 5,116,461 | 05/26/92 | Lebby et al. | | | | |
| | EH - | 5,127,067 | 06/30/92 | Delcoco et al. | | | | |
| | EI | 5,144,409 | 09/01/92 | Ма | | | | |
| | EJ | 5,293,050 | 03/08/94 | Chapple-Sokol et al | | | | |
| | EK EL | 5,356,831 | 10/18/94 | Calviello et al. | | | | |
| | EM | 5,391,515 | 02/21/95 | Kao et al. | | | | |
| | EN | 5,442,191 5,444,016 | 08/15/95 | Ma | | | | |
| | EO | 5,480,829 | 08/22/95 | Abrokwah, et al. | | | | |
| | EP | 5,528,414 | 01/02/96 | Abrokwah, et al. | | | | |
| | EQ | 5,614,739 | 06/18/96 | Oakley | | | | |
| | ER | 5,729,394 | 03/25/97 | Abrokwah et al. | | | | |
| | ES | 5,731,220 | 03/17/98 | Sevier et al. | | | | |
| | ET | 5,764,676 | 03/24/98 | Tsu et al. | | | | |
| | | 5,777,762 | 06/09/98 | Paoli et al. | | | | |
| | EV | 5,778,018 | 07/07/98 07/07/98 | Yamamoto | | | | |
| | | 5,778,116 | 07/07/98 | Yoshikawa et al. | | | | |
| | X | 5,801,105 | | Tomich | | | | |
| | | 5,828,080 | 09/01/98 10/27/98 | Yano et al. | | | | |
| | | 5,858,814 | 01/12/99 | Yano et al. | | | | |
| | | 5,861,966 | 01/12/99 | Goossen et al. | | | | |
| | | 5,883,996 | 03/16/99 | Ortel | | | | |
| | | 5,995,359 | 11/30/99 | Knapp et al. | | | | |
| | | 6,058,131 | 05/02/00 | Kiee et al. | | | | |
| F | | 6,137,603 | 10/24/00 | Henmi | | | | |
| F | | 6,146,906 | 11/14/00 | Inoue et al. | | | | |
| F | 1 | 6,173,474 | 01/16/01 | Conrad | | | | |
| FI | | 6,180,252 | 01/30/01 | Farrell et al. | | | | |
| FI | | 4,242,595 | 12/30/0 | Lehovec | | | | |
| FJ | | 4,398,342 | 08/16/83 | Pitt et al. | | | | |
| Fr | | 1,424,589 | 01/03/84 | Thomas et al. | | | | |
| FL | | 4,876,208 | 10/24/89 | Gustafson et al. | | | | |
| FN | | 1,482,422 | 11/84 | McGinn et al. | | | | |
| FN | | ,667,088 | 05/19/87 | Kramer | <u> </u> | | | |
| FC | | ,772,929 | | Manchester et al. | | | | |
| FP | | ,841,775 | | Ikeda et al. | | | | |
| FC | | ,845,044 | | Ariyoshi et al. | | | | |

| Form PTO 1449 (Modified) | | II C DEDARTMENT OF COL | | | | | <u> 1EET 4 OF 2</u> |
|-----------------------------|------|---|------------|--------------------------------|----------------|-----------------|---------------------|
| II . | P | U.S. DEPARTMENT OF COMPATENT AND TRADEMARK OF | MERCE | ATTY DOCKET NO. 248402US99DIV | | SERIAL | NO. 10/767,994 |
| LIST OF F | REFE | RENCES CITED BY A | ODI ICANIT | APPLICANT | | | |
| | | THE TOTAL OF THE BY A | LICANI | FILING DATE | Jamal RAMDANI, | | |
| | | | | February 2, 2004 | | GROUP | 2815 |
| | | | | II S DATENT DOCUMENTS | | · | |
| EXAMINER | | DOCUMENT | DATE | U.S. PATENT DOCUMENTS NAME | CLASS | SUB | FILING DATE |
| INITIAL | SA. | NUMBER 4,868,376 | 09/19/89 | Lessin et al. | | CLASS | IF APPROPRIATE |
| <u> </u> | SB | 4,885,376 | 12/05/89 | Verkade | | | |
| | GC | 4,888,202 | 12/89 | Murakami et al. | <u> </u> | | |
| | SD. | 4,891,091 | 12/90 | Wanlass et al. | | | |
| | E E | 5,051,790 | 09/24/91 | Hammer | | | |
| | SF. | 5,055,445 | 10/08/91 | Belt et al. | | - | |
| | | 5,081,519 | 11/14/92 | Nishimura et al. | | | |
| | | 5,143,854 | 09/01/92 | Pirrung et al. | | | |
| G | | 5,185,589 | 02/09/93 | Krishnaswamy et al. | | | |
| G | | 5,191,625 | 03/02/93 | Gustavsson | | | |
| G | | 5,194,397 | 03/16/93 | Cook et al. | | | |
| G | | 5,208,182 | 05/04/93 | Narayan et al. | | | |
| | | 5,216,729 | 06/01/93 | Berger et al. | | <u></u> | · |
| Gi | | 5,314,547 | 05/24/94 | Heremans et al. | | | |
| G | | 5,352,926 | 10/04/94 | Andrews | | | |
| GI | | 5,356,509 | 10/18/94 | Terranova et al. | | | |
| G | | 5,371,734 | 12/06/94 | Fischer | | | |
| GI | | 5,372,992 | 12/94 | Itozaki et al. | | | |
| G | | 5,405,802 | 04/11/95 | Yamagata et al. | | | |
| G1 | | 5,442,561 | 08/15/95 | Yoshizawa et al. | | | |
| Gi | υ | 5,453,727 | 09/26/95 | Shibasaki et al. | | | |
| G\ | V | 5,466,631 | 11/14/95 | Ichikawa et al. | | | |
| Gv | N : | 5,473,047 | 12/05/95 | Shi | | | • |
| GX | X | 5,473,171 | 12/95 | Summerfelt | | | |
| GY | 7 | 5,479,033 | 12/26/95 | Baca et al. | | | |
| GZ | 2 5 | 5,486,406 | 01/23/96 | Shi | | | · |
| HA | | 5,491,461 | 02/13/96 | Partin et al. | | | |
| НВ | 3 | 5,492,859 | 02/20/96 | Sakaguchi et al. | | | |
| НС | ; 5 | 5,494,711 | 02/27/96 | Takeda et al. | | | |
| HD | 5 | 5,504,035 | 04/02/96 | Rostoker et al. | | | |
| HE | 5 | ,504,183 | 04/02/96 | Shi | | | |
| HF | 5 | ,511,238 | 04/23/96 | Bayraktaroglu | + | | |
| HG | 5 5 | ,512,773 | 04/96 | Wolf et al. | | | |
| нн | 5 | ,515,047 | 05/07/96 | Yamakido et al. | | | |
| н | 5 | ,515,810 | 05/14/96 | Yamashita et al. | | | |
| HJ | 5 | ,519,235 | 05/96 | Ramesh | | | |
| нк | 5 | ,549,977 | 08/96 | Jin et al. | | | |
| HL | 5 | ,551,238 | 09/03/96 | Prueitt | | | |
| НМ | 5, | ,552,547 | 09/03/96 | Shi | + | | <u> </u> |
| HN | 5, | 589,284 | 12/31/96 | Summerfelt et al. | | | |
| НО | 5, | 602,418 | 02/11/97 | lmai et al. | | - - | |
| HP | 5, | 633,724 | 05/27/97 | King et al. | | | |

| | | | | | | SI | HEET 5 OF 23 | |
|--|---------------------------------------|--------------------|----------------------------------|----------------------------------|--------|-------------------|-------------------------------|--|
| Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE | | | ATTY DOCKET NO. 248402US99DIV | | SERIAL | NO. 10/767,994 | | |
| LIST OF | LIST OF REFERENCES CITED BY APPLICANT | | | APPLICANT Jamal RAMDANI, et al. | | | | |
| | | | FILING DATE | ITAMDAM | GROUP | | | |
| | | | February 2, 2004 | | 2815 | | | |
| EVALUED | | DOCUMENT | 0.75 | U.S. PATENT DOCUMENTS | 101400 | Louis | EII NO BATE | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE | |
| · | IA | 5,650,646 | 07/22/97 | Summerfelt | | | | |
| | ΙB | 5,656,382 | 08/12/97 | Nashimoto | | | | |
| | IC | 5,659,180 | 08/19/97 | Shen et al. | | | | |
| | ID | 5,661,112 | 08/26/97 | Hatta et al. | | | | |
| | IE | 5,679,965 | 11/95 | Schetzina | | | | |
| | lF | 5,725,641 | 03/10/98 | MacLeod | | | | |
| | IG | 5,745,631 | 04/28/98 | Reinker | | | | |
| | IH | 5,776,621 | 07/07/98 | Nashimoto | | | | |
| | П | 5,777,350 | 07/07/98 | Nakamura et al. | | | | |
| | IJ | 5,789,845 | 08/04/98 | Wadaka et al. | | | | |
| | IK | 5,792,569 | 08/11/98 | Sun et al. | | | | |
| | IL | 5,792,679 | 08/11/98 | Nakato | | | | |
| | IМ | 5,796,648 | 08/18/98 | Kawakubo et al. | | | | |
| | IN · | 5,801,072 | 09/01/98 | Barber | | | | |
| | 10 | 5,812,272 | 09/22/98 | King et al. | | | | |
| | ΙP | 5,814,583 | 09/98 | Itozaki et al. | | | | |
| | IQ | 5,825,055 | 10/20/98 | Summerfelt | | | | |
| | IR | 5,827,755 | 10/27/98 | Yonchara et al. | | | | |
| | IS | 5,833,603 | 11/10/98 | Kovacs et al. | | | | |
| | ΙT | 5,838,035 | 11/17/98 | Ramesh | | | | |
| | IU. | 5,844,260 | 12/01/98 | Ohori | | | | |
| | IV | 5,846,846 | 12/08/98 | Suh et al. | | | | |
| | IW | 5,863,326 | 01/26/99 | Nause et al. | | | | |
| | IX | 5,872,493 | 02/16/99 | Ella | | | | |
| | ΙΥ | 5,879,956 | 03/99 | Seon et al. | | | | |
| | IZ | 5,880,452 | 03/09/99 | Plesko | | | | |
| | JA | 5,883,564 | 03/16/99 | Partin | | | | |
| | JB | 5,907,792 | 05/25/99 | Droopad et al. | | | | |
| | JC | 5,937,274 | 08/10/99 | Kondow et al. | | | | |
| | JD | 5,948,161 | 09/07/99 | Kizuki | | | | |
| | JE | 5,959,879 | 09/28/99 | Koo | | | | |
| | JF | 5,966,323 | 10/99 | Chen et al. | | | | |
| | JG | 5,987,011 | 11/16/99 | Toh | | | | |
| | JH | 6,022,140 | 02/08/00 | Fraden et al. | | | | |
| | JI | 6,022,410 | 02/08/00 | Yu et al. | | | | |
| | JJ | 6,023,082 | 02/08/00 | McKee et al. | | | | |
| | JK | 6,028,853 | 02/22/00 | Haartsen | | | | |
| | JL | 6,049,702 | 04/11/00 | Tham et al. | | | | |
| | JM | 6,078,717 | 06/20/00 | Nashimoto et al | | | | |
| | JN | 6,088,216 | 07/00 | Laibowitz et al. | | | | |
| | 10 | 6,090,659 | 07/00 | Laibowitz et al. | | | | |
| | JP | 6,107,721 | 08/22/00 | Lakin | | | | |
| | JQ | 6,153,010 | 11/28/00 | Kiyoku et al | | | | |

| | | | | | | | IEET 6 OF 23 | |
|-----------------------------|---------------------------------------|--|-------------|----------------------------------|-----------|------------------|-----------------------------|--|
| Form PTO 1449 (Modified) | F | U.S. DEPARTMENT OF COM PATENT AND TRADEMARK OFF | | ATTY DOCKET NO. 248402US99DIV | | SERIAL N | NO. 10/767,994 | |
| LIST OF | LIST OF REFERENCES CITED BY APPLICANT | | | APPLICANT Jamal RAMDANI, et al. | | | | |
| | | | | FILING DATE | | GROUP | | |
| | · · · · · · · · · · · · · · · · · · · | | | February 2, 2004 | | 2815 | | |
| EVALUEE | | T DOCUMENT | DATE | U.S. PATENT DOCUMENTS | T C! A CC | CUID SILVIO DATE | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE | |
| | KA | 6,153,454 | 11/28/00 | Krivokapic | | | | |
| | КВ | 6,191,011 | 02/01 | Gilboa et al | | | | |
| ***** | кс | 6,204,737 | 03/20/01 | Ella | | | | |
| | KD | 6,224,669 | 05/01/01 | Yi et al. | | | | |
| | KE | 6,225,051 | 05/01/01 | Sugiyama et al. | | | | |
| | KF | 6,241,821 | 06/05/01 | Yu et al. | | | | |
| | KG | 6,265,749 | 07/24/01 | Gardner et al. | | | | |
| | кн | 6,313,486 | 11/01 | Kencke et al. | | | | |
| | ΚI | 6,316,832 | 11/13/01 | Tsuzuki et al. | | ŀ | | |
| | KJ | 2002/0008234 | 01/02 | Emrick | | | | |
| | KK | 3,670,213 | 06/13/72 | Nakawaga et al. | | | | |
| | KL | 4,756,007 | 07/05/88 | Qureshi et al. | | | | |
| | KM | 4,773,063 | 09/20/88 | Hunsperger et al. | | | | |
| | KN | 5,394,489 | 02/28/95 | Koch | | | | |
| | ко | 5,406,202 | 04/11/95 | Mehrgardt et al. | | | | |
| | KP | 5,528,067 | 06/18/96 | Farb et al. | | | | |
| | KQ | 5,572,052 | 11/05/96 | Kashihara et al. | | | | |
| | KR | 5,767,543 | 06/16/98 | Ooms et al. | | | | |
| | KS | 6,175,497 | 01/16/01 | Tseng et al. | | | | |
| | KT | 6,197,503 | 03/06/01 | Vo-Dinh et al. | | | | |
| | KU | 6,248,459 | 06/19/01 | Wang et al. | | | | |
| | ΚV | 6,252,261 | 06/26/01 | Usui et al. | | | | |
| | KW | 6,255,198 | 07/03/01 | Linthicum et al. | | | | |
| FI : | кх | 6,268,269 | 07/31/01 | Lee et al. | | | | |
| | KY | 6,291,319 | 09/18/01 | Yu et al. | | | | |
| | KZ | 6,316,785 | 11/13/01 | Nunoue et al. | | | · | |
| | \$ | 6,343,171 | 01/29/02 | Yoshimura et al. | | | | |
| | LB | 4,965,649 | 10/23/90 | Zanio et al. | | | | |
| | LC | 6,253,649 | 05/01 | Kawahara et al. | | | | |
| | LD | 6,211,096 | 04/01 | Allman et al. | | | | |
| | LE | 6,239,449 | 05/29/01 | Fafard et al. | | | | |
| | LF | 2001/0013313 | 08/16/01 | Droopad et al. | | | | |
| | LG | 6,184,044 | 02/06/01 | Sone et al. | | | | |
| | LH | 6,011,646 | 01/04/00 | Mirkarimi et al. | <u> </u> | | | |
| | LI | 5,227,196 | 07/13/93 | ltoh | | | | |
| | LJ | 6,150,239 | 11/21/00 | Goesele et al. | | | | |
| | LK | 5,441,577 | 08/15/95 | Sasaki et al. | | | | |
| | LL | 4,459,325 | 07/10/84 | Nozawa et al. | | LI | | |
| <u> </u> | LM | 4,392,297 | 07/12/83 | Little | | | | |
| | LN | 4,289,920 | 09/15/81 | Hovel | | | | |
| | LO | 5,281,834 | 01/25/94 | Cambou et al. | | | | |
| | LP | 4,901,133 | 02/13/90 | Curran et al. | | | | |
| | LQ | 5,514,904 | 05/07/96 | Onga et al. | | | | |

| Form PTO 1449 (Modified) | P/ | U.S. DEPARTMENT OF COMM ATENT AND TRADEMARK OFFIC | | ATTY DOCKET NO. | | SERIAL | |
|-----------------------------|---------------------------------------|--|-------------|----------------------------|-------|--------------|---------------------------------------|
| (:: | | | | 248402US99DIV APPLICANT | | | 10/767,994 |
| LIST OF | LIST OF REFERENCES CITED BY APPLICANT | | | Jamal RAMDANI, | | , et al. | |
| | | | FILING DATE | | GROUP | | |
| | | | • | February 2, 2004 | | | 2815 |
| EVALUED | | DOCUMENT | | U.S. PATENT DOCUMENTS | | CUD | FILINO DATE |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE |
| | MA | 5,553,089 | 09/03/96 | Seki et al. | | | |
| | МВ | 5,528,057 | 06/18/96 | Yanagase et al. | | | |
| | мс | 6,229,159 | 05/08/01 | Suzuki | | | |
| | MD | 4,748,485 | 05/31/88 | Vasudev | | | |
| | ME | 4,984,043 | 01/08/91 | Vinal | | | |
| | MF | 5,754,319 | 05/19/98 | Van De Voorde et al. | | | |
| | MG | 6,108,125 | 08/22/00 | Yano | | | |
| | МН | 5,073,981 | 12/17/91 | Giles et al. | | | |
| | МІ | 5,140,651 | 08/18/92 | Soref et al. | | | |
| | MJ | 5,610,744 | 03/11/97 | Ho et al. | | | |
| | мк | 6,362,017 | 03/26/02 | Manabe et al. | | • | |
| | ML | 6,242,686 | 06/05/01 | Kishimoto et al. | | | |
| | ММ | 5,689,123 | 11/18/97 | Major et al. | | | |
| | MN | 5,670,800 | 09/23/97 | Nakao et al. | | | |
| | МО | 5,067,809 | 11/26/91 | Tsubota | - | | |
| | MP | 5,596,205 | 01/21/97 | Reedy et al. | | | |
| | MQ | 6,175,555 | 01/16/01 | Hoole | | | |
| | MR | 5 ,357,122 | 10/18/94 | Okubora et al. | | | |
| | мѕ | 4,084,130 | 04/11/78 | Holton | | | |
| | мт | 6,093,302 | 07/25/00 | Montgomery | | | |
| | MU | 6,372,813 | 04/16/02 | Johnson et al. | | | |
| | MV | 5,608,046 | 03/04/97 | Cook et al. | | | |
| | MW | 5,955,591 | 09/21/99 | Imbach et al. | | | |
| | MX | 6,022,963 | 02/08/00 | McGall et al. | | | ····· |
| | MY | 6,083,697 | 07/04/00 | Beecher et al. | | | |
| | MZ | 5,063,081 | 11/05/91 | Cozzette et al. | | | |
| | NA | 5,479,317 | 12/26/95 | Ramesh | | | • |
| | NB | 5,306,649 | 04/26/94 | Hebert | | | |
| | NC | 5,962,069 | 10/05/99 | Schindler et al. | | | |
| | ND | 5,541,422 | 07/30/96 | Wolf et al. | | | · · · · · · · · · · · · · · · · · · · |
| | NE | 5,873,977 | 02/23/99 | Desu et al. | | | |
| | NF | 5,538,941 | 07/23/96 | Findikoglu et al. | | | - · |
| | NG | 6,046,464 | 04/04/00 | Schetzina | | | |
| | NH | 6,235,145 | 05/22/01 | Li et al. | | | |
| | NI | 5,610,744 | 03/11/97 | Ho et al. | | | |
| | NJ | 5,280,013 | 01/18/94 | Newman et al. | | | |
| | NK | 6,348,373 B1 | 02/19/02 | Ma et al. | | | |
| • | NL | 6,339,664 B1 | 01/15/02 | Farjady et al. | | | |
| | | 4,439,014 | 03/27/84 | Stacy et al. | | | |
| | NN | 4,889,402 | 12/26/89 | Reinhart | | | |
| | | 5,963,291 | 10/05/99 | Wu et al. | | | |
| | | 6,011,641 | 01/04/00 | Shin et al. | | | |
| | | 6,340,788 B1 | 01/22/02 | King et al. | | | |
| i | .,,,,, | 5,5 10,7 00 5 1 | V 1122102 | Timig Stal. | | 1 | |

Sheets 8 OF 23

U.S. DEPARTMENT OF COMMERCE Form PTO 1449 (Modified) SERIAL NO. ATTY DOCKET NO. PATENT AND TRADEMARK OFFICE 248402US99DIV 10/767,994 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Jamai RAMDANI, et al. FILING DATE GROUP February 2, 2004 2815 **U.S. PATENT DOCUMENTS EXAMINER** DOCUMENT SUB **FILING DATE** DATE **CLASS** NAME INITIAL NUMBER **CLASS** IF APPROPRIATE 5,807,440 09/15/98 OA Kubota et al. 4,681,982 07/21/87 OB Yoshida OC 4,629,821 12/16/86 Bronstein-Bonte et al. OD 4,452,720 06/05/84 Harada et al. 3.935.031 01/27/76 OE Adler OF 5,760,426 06/02/98 Marx et al. OG 5,053,835 10/01/91 Horikawa et al. ОН 6,326,645 B1 12/04/01 Kadota OI 5,770,887 06/23/98 Tadatomo et al. 6,372,356 B1 OJ 04/16/02 Thornton et al. OK 4,774,205 09/27/88 Choi et al. OL 6,359,330 B1 03/19/02 Goudard OM 5,312,765 05/17/94 Kanber ON 5,734,672 03/31/98 McMinn et al. 00 6,367,699 B2 04/09/02 Ackley OP 5,530,235 06/25/96 Stefik et al. 5,623,552 ററ 04/22/97 Lane 01/02/96 OR 5,481,102 Hazelrigg, Jr. os 6,134,114 10/17/00 Ungermann et al. Nevill OT 5,984,190 11/16/99 ΟU 5,789,733 08/04/98 Jachimowicz et al. OV 5,753,300 05/19/98 Wessels et al. OW 6,208,453 03/27/01 Wessels et al. OX 5,886,867 03/23/99 Chivukula et al. OY 5,028,976 07/02/91 Ozaki et al. ΟZ 5,869,845 02/09/99 Vander Wagt et al. PA 5,596,214 01/21/97 Endo PB 6,391,674 B2 05/21/02 Ziegler PC 08/14/01 6,275,122 B1 Speidell et al. PD 6,238,946 B1 05/29/01 Ziegler PE 6,210,988 B1 04/03/01 Howe et al. 6,392,257 05/21/02 Ramdani et al. PG 4,442,590 04/17/84 Stockton et al. PH 5.603,764 02/18/97 Matsuda et al. PI 6,087,681 06/11/00 Shakuda PJ 5,132,648 07/21/92 Trinh et al. PK 6,427,066 07/30/02 Grube PL 2002/0072245 06/13/02 Ooms et al. PM 6,278,138 B1 08/21/01 Suzuki PΝ Ooms et al. 5,888,296 03/30/99 PO 5,198,269 03/3093 Swartz et al. PP 2002/0030246 03/14/02 Eisenbeiser et al. PQ 2002/0047143 04/25/02 Ramdani et al.

| 9 4 | | | T | | SHEET 9 OF 23 | | |
|-----------------------------|--|---------------------|----------------------|----------------------------------|--|--|---------------------------------------|
| Form PTO 1449 (Modified) | 1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | | | ATTY DOCKET NO. 248402US99DIV | | SERIAL | NO. 10/767,994 |
| | | | | APPLICANT | | i | 101101,004 |
| LIST OF | REFE | RENCES CITED BY APP | LICANT | Jamal R | , et al. | | |
| | | | | FILING DATE February 2, 2004 | | GROUP | 2815 |
| | | | | U.S. PATENT DOCUMENTS | | <u> </u> | |
| EXAMINER | | DOCUMENT | T | T | CLASS | SUB | FILING DATE |
| INITIAL | | NUMBER | DATE | NAME | CLASS | CLASS | IF APPROPRIATE |
| | QA | 5,776,359 | 07/07/98 | Schultz et al. | ļ | | |
| | QB | 5,569,953 | 10/29/96 | Kikkawa et al. | ļ | | |
| | QC | 5,834,362 | 11/10/98 | Miyagaki et al. | | | |
| | QD | 6,248,621 B1 | 06/19/01 | Wilk et al. | ļ | | |
| | QE | 5,266,355 | 11/30/93 | Wernberg et al. | 1 | | |
| | QF | 6,277,436 B1 | 08/21/01 | Stauf et al. | | | |
| | QG | 6,039,803 | 03/21/00 | Fitzgerald et al. | | | |
| | QH | 5,619,051 | 04/08/97 | Endo | <u> </u> | | |
| | QI | 5,420,102 | 05/30/95 | Harshavardhan et al. | | | |
| | Q٦ | 5,210,763 | 05/11/93 | Lewis et al. | <u> </u> | <u> </u> | |
| | QK | 5,103,494 | 04/07/92 | Mozer | | | |
| | QL | 4,594,000 | 06/10/86 | Falk et al. | ļ | | |
| | QM | 4,297,656 | 10/27/81 | Pan | <u> </u> | | |
| | QN | 5,244,818 | 09/14/93 | Jokers et al. | <u> </u> | | |
| | QO | 6,048,751 | 04/11/00 | D'Asaro et al. | | | |
| | QP | 5,484,664 | 01/16/96 | Kitahara et al. | <u> </u> | | |
| | QQ | 5,780,311 | 07/14/98 | Beasom et al. | - | | |
| | QR | 6,438,281 B1 | 08/20/02 | Tsukamoto et al. | | | |
| | QS | 5,399,898 | 03/21/95 | Rostoker | 1 | | |
| | QT | 6,271,619 | 08/07/01 | Yamada et al. | | | · · · · · · · · · · · · · · · · · · · |
| | QU | 5,334,556 | 08/02/94 | Guldi | | | |
| | QV | 4,910,164 | 03/20/90 | Shichijo | | | |
| | QW | 4,952,420 | 08/28/90 | Walters | | | |
| | QX | 6,121,647 | 09/19/00 | Yano et al. | | | |
| | QY | 6,306,668 B1 | 10/23/01 | McKee et al. | | | |
| | QZ BA | 6,143,366 | 11/07/00 06/25/02 | Taylor et al. | 1 | - | |
| | RA RB | 5,397,428 | 06/25/02 | Stoner et al. | | | |
| | RC | 6,432,546 B1 | 08/13/02 | Ramesh et al. | | | |
| | RD | 6,345,424 | 02/12/02 | Hasegawa et al. | | | |
| | RE | 6,338,756 B2 | 01/15/02 | Dietze | | | |
| | RF | 5,516,725 | 05/14/96 | Chang et al. | | 1 | |
| | RG | 4,667,212 | 05/19/87 | Nakamura | | | |
| | RH | 5,629,534 | 05/13/97 | Inuzuka et al. | | | |
| | RI | 3,914,137 | 10/21/75 | Huffman et al. | | | |
| | RJ | 5,753,928 | 05/19/98 | Krause | | | |
| | RK | 5,977,567 | 11/02/99 | Verdiell | | | |
| | RL | 5,130,762 | 07/14/92 | Kulick | | | |
| | RM | 5,621,227 | 04/15/97 | Joshi | 1 | | |
| | RN | 6,389,209 B1 | 05/14/02 | Suhir | | | |
| | | 5,163,118 | 11/10/92 | Lorenzo et al. | | | |
| | RO I | | | | | | |
| | RO RP | 5,926,493 | 07/20/99 | O'Brien et al. | | | |

SERIAL NO. U.S. DEPARTMENT OF COMMERCE ATTY DOCKET NO. Form PTO 1449 (Modified) PATENT AND TRADEMARK OFFICE 10/767,994 248402US99DIV **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Jamal RAMDANI, et al. FILING DATE **GROUP** 2815 February 2, 2004 **U.S. PATENT DOCUMENTS DOCUMENT** SUB **FILING DATE EXAMINER CLASS** DATE NAME **CLASS** IF APPROPRIATE NUMBER INITIAL 6,156,581 12/05/00 Vaudo et al. SB 5,395,663 03/07/95 Tabata et al. 03/27/79 Alferness et al. SC 4,146,297 09/19/95 SD 5,452,118 Maruska 03/30/99 Imamura et al. SE 5,889,296 Shinohara et al. SF 6,300,615 B1 10/09/01 05/15/01 Bell et al. 6,232,910 B1 SG SH 5,686,741 11/11/97 Ohori et al. SI 4,959,702 09/25/90 Moyer et al SJ 6,100,578 08/08/00 Suzuki 06/25/02 Wada SK 6,410,947 B1 SL 6,417,059 B2 07/09/02 Huang SM 6,461,927 B1 10/08/02 Mochizuki et al. Higgins, Jr. et al. 10/08/02 SN 6,462,360 B1 11/09/99 Murasato so 5,981,976 SP 5,981,980 11/09/99 Miyajima et al. 2002/0006245 A1 01/17/02 Kubota et al. SQ 2002/0131675 A1 SR 09/19/02 Litvin 07/03/01 Duchet SS 6,256,426 B1 6,278,523 B1 08/21/01 Gorecki ST Ramdani et al. 6,319,730 B1 11/20/01 SU 06/11/02 Hong et al. SV 6,404,027 SW 6,312,819 B1 11/06/01 Jia et al. 5,119,448 06/02/92 Schaefer et al. SX 10/17/78 Chaum SY 4,120,588 03/16/93 SZ 5,194,917 Regener 05/28/91 TA 5,018,816 Murray et al. тв 5,953,468 09/14/99 Finnila et al. 5,561,305 10/01/96 Smith TC 04/20/99 Wisseman et al. 5,896,476 TD 06/19/90 Jou et al. TE 4,934,777 11/20/01 Kizilyalli et al. TF 6,320,238 B1 05/21/02 Davis et al. TG 6,393,167 B1 06/02/98 Onda TH 5,760,427 06/25/02 Sadot et al. TI 6,411,756 B2 TJ 5,668,048 09/16/97 Kondo et al. Wickham ΤK 5,852,687 12/22/98 06/16/92 Chan et al. TL 5,122,852 ТМ 5,173,835 12/22/92 Cornett et al. 10/08/91 Sutton TN 5,055,835 10/31/00 6,139,483 Seabaugh et al. TO 02/01/94 Stengel 5,283,462 TP 08/15/00 TQ Grigorian et al. 6,103,403

U.S. DEPARTMENT OF COMMERCE ATTY DOCKET NO. SERIAL NO. Form PTO 1449 PATENT AND TRADEMARK OFFICE (Modified) 248402US99DIV 10/767,994 APPLICANT LIST OF REFERENCES CITED BY APPLICANT Jamal RAMDANI, et al. GROUP FILING DATE 2815 February 2, 2004 **U.S. PATENT DOCUMENTS** FILING DATE **DOCUMENT** SUB **EXAMINER** DATE **CLASS** NAME IF APPROPRIATE CLASS INITIAL NUMBER 5,635,433 06/03/97 UA Sengupta 06/27/95 UB 5,427,988 Sengupta et al. UC 6,297,842 B1 10/02/01 Koizumi et al. UD 5,682,046 10/28/97 Takahashi et al. 01/19/93 Moon et al. UΕ 5,181,085 UF 6,051,858 04/18/00 Uchida et al. UG 6,013,553 01/11/00 Wallace et al. UH 4,872,046 10/03/89 Morkoc et al. 04/25/02 Ramdani et al. 2002/0047123 A1 UI UJ 5,995,528 11/30/99 Fukunaga et al. UK 5,075,743 12/24/91 Behfar-Rad UL 5,438,584 08/01/95 Paoli et al. 03/05/85 Nakashima et al. UM 4,503,540 UN 5,373,166 12/13/94 Buchan et al. 6,278,137 B1 08/21/01 Shimoyama et al. UO UP 04/22/97 Gotoh et al. 5,623,439 01/01/91 Ohno et al. UQ 4,981,714 UR 6,194,753 B1 02/27/01 Seon et al. 12/04/01 Parkin et al. US 6,326,637 B1 UT UU UV UW UX UY UΖ VA VΒ VC VD VΕ VF VG VΗ VI VJ VΚ VL VM VN VO VP VQ

| [= ================================== | | U.C. DEDARTMENT OF COMM | -DCC | ATTY DOCKET NO. | SERIAL NO. |
|--|-------|---|-----------|-------------------------------|--|
| Form PTO 1449 (Modified) | PA | U.S. DEPARTMENT OF COMME ATENT AND TRADEMARK OFFIC | | 248402US99DIV | 10/767,994 |
| | | | | APPLICANT | |
| LIST OF R | REFEF | RENCES CITED BY APP | LICANT | Jamal RAMDANI, FILING DATE | et al. GROUP |
| | | | | February 2, 2004 | 2815 |
| | | | · | U.S. PATENT DOCUMENTS | |
| | | DOCUMENT | DATE | COUNTRY | TRANSLATION |
| | | NUMBER | | | VES NO |
| | | | | | YES NO |
| | | 0 250 171 | 12/23/87 | | X |
| | | 0 342 937 | 11/23/89 | EP | X |
| | | 0 455 526 | 06/11/91 | EP | X |
| | | 0 602 568 | 06/22/94 | EP | X |
| A | ΛE | 0 607 435 | 07/27/94 | EP | × |
| A | | 1 001 468 | 05/17/00 | EP | × |
| A | AG | 0 514 018 | 11/19/92 | EP | × |
| A | AΗ | 0 999 600 | 05/10/00 | EP | × |
| A | Δĺ | 1 319 311 | 06/04/70 | Great Britain | × |
| Α | ΑJ | 5-291299 | 11/05/93 | Japan w/English Abstract | X |
| Α | AK | 11-238683 | 08/31/99 | Japan | × |
| A | AL | 11-260835 | 09/24/99 | Japan w/English Abstract | × |
| A | ΑM | HEI 2-391 | 01/05/90 | Japan w/English Abstract | × |
| - A | AÑ | 5-48072 | 02/26/93 | Japan w/English Abstract | × |
| A | AO | 52-88354 | 07/23/77 | Japan w/English Abstract | × |
| A | AP | 54-134554 | 10/19/79 | Japan w/English Abstract | × |
| <u> </u> A | AQ | 55-87424 | 07/02/80 | Japan w/English Abstract | × |
| A | AR | 61-108187 | 05/26/86 | Japan w/English Abstract | × |
| A | AS | 6-232126 | 08/19/94 | Japan | × |
| h | ΑT | 6-291299 | 10/18/94 | Japan w/English Abstract | × |
| A | AU | 63-34994 | 02/15/88 | Japan w/English Abstract | x , |
| A | ΑV | 63-131104 | 06/03/88 | Japan w/English Abstract | × |
| _A | AW | 63-198365 | 08/17/88 | Japan w/English Abstract | × |
| h | AX | 10-321943 | 12/04/98 | Japan | × |
| - | AY | 6-334168 | 12/02/94 | Japan | × |
| h | ΑZ | WO 99/63580 | 12/09/99 | WIPO | × |
| | BA | WO 99/14804 | 03/25/99 | WIPO | × |
| | | | 12/04/97 | WIPO | |
| | | | 04/22/99 | WIPO | |
| | | | 06/08/00 | WIPO | |
| | | | | WIPO | |
| | | | 03/25/99 | WIPO | |
| | | | 09/29/99 | Great Britain | |
| | | | | Europe | <u> </u> |
| | | | 10/30/97 | Germany | k |
| | | 60-212018 | 10/24/85 | Japan w/English Abstract | |
| | | 60-210018 | 10/22/85 | Japan w/English Abstract | |
| | | | | WIPO | |
| | | | 11/15/95 | Europe | |
| | | | 02/91 | Japan (English Abstract only) | |
| | | | | Europe | |
| | | | 01/16/96 | Japan | |
| | | | 06/16/00 | Japan | |
| ^A | BQ | 2 000 1645 | 55, 10,00 | papan | |

| ········ | | | | | SHEET | 13 OF 23 |
|-----------------------------|------|---|----------|----------------------------------|--|--------------|
| Form PTO 1449 (Modified) | PA | U.S. DEPARTMENT OF COMM ATENT AND TRADEMARK OFFICE | | ATTY DOCKET NO. 248402US99DIV | SERIAL NO. 10/76 | 67,994 |
| | | | | APPLICANT | | |
| LIST OF F | REFE | RENCES CITED BY APP | LICANT | Jamal RAMDANI FILING DATE | , et al. GROUP | |
| | | | | February 2, 2004 | | 315 |
| | | | | U.S. PATENT DOCUMENTS | | |
| | | DOCUMENT | DATE | COUNTRY | TRANS | SLATION |
| | | NUMBER | | | YES | NO |
| E | BAA | 1 043 426 | 10/11/00 | Europe | | |
| | BAB | 2000-068466 | 03/00 | Japan (Abstract) | | |
| E | BAC | 64-50575 | 02/27/89 | Japan | | |
| E | BAD | WO 98/05807 | 01/12/98 | WIPO | | |
| E | BAE | WO 94/03908 | 02/17/94 | WIPO | | |
| E | BAF | WO 01/33585 | 05/10/01 | WIPO | | |
| E | BAG | 1-102435 | 04/20/89 | Japan w/English Abstract | | |
| E | BAH | 52-135684 | 11/12/77 | Japan (English Abstract) | | |
| | | 02051220 | 02/21/90 | Japan (English Abstract) | | |
| | | 11135614 | 05/21/99 | Japan (w/English Abstract) | | |
| | | 64-52329 | 02/28/89 | Japan (w/English Abstract) | | |
| | BAL | 10-256154 | 09/25/98 | Japan (w/English Abstract) | | |
| | | DE 196 07 107 | 08/28/97 | Germany | | xx |
| | | 10-303396 | 11/13/98 | Japan (w/English Abstract) | 1 | |
| | | 58-213412 | 12/12/83 | Japan w/English Abstract | | |
| | | 0 964 259 | 12/15/99 | Europe | 1 | |
| | · | 0 875 922 | 11/04/98 | Europe | | |
| | | 61-63015 | 04/01/86 | Japan w/English Abstract | <u> </u> | |
| | | | 12/10/99 | Japan (English Abstract) | | • |
| | - | 11340542 | 05/25/01 | WIPO | | |
| | | WO 01/37330 | | | | |
| | | 0 331 467 | 09/06/89 | Europe | | |
| | | WO 00/16378 | 03/23/00 | WIPO | - | |
| | | 0 926 739 | 06/30/99 | Europe | | |
| | BAX | 0 964 453 | 12/15/99 | Europe | | |
| | BAY | 5-152529 | 06/18/93 | Japan w/English Abstract | | |
| E | BAZ | 9-67193 | 03/11/97 | Japan w/English Abstract | | |
| E | BBA | 9-82913 | 03/28/97 | Japan w/English Abstract | · | |
| | BBB | 0 309 270 | 03/29/89 | Europe | | |
| E | BBC | EP 0 957 522 | 11/17/99 | Europe | | |
| E | BBD | EP 0 810 666 | 12/03/97 | Europe | | |
| E | BE | 1-179411 | 07/17/89 | Japan w/English Abstract | | |
| E | BF | DE 100 17 137 | 10/26/00 | GERMANY | | |
| E | BG | WO 02 01648 | 01/03/02 | WIPO | | |
| E | вн | WO 02/33385 A2 | 04/25/02 | WIPO | | |
| E | BI | WO 01/59814 A2 | 08/16/01 | WIPO | | |
| · | BJ | WO 02/09160 A2 | 01/31/02 | WIPO | | |
| E | вк | WO 00/06812 | 02/10/00 | WIPO | | |
| E | BL | 0 483 993 | 05/06/92 | Europe | | |
| E | ВМ | 0 538 611 | 04/28/93 | Europe | | |
| E | BN | WO 01/59820 A1 | 08/16/01 | WIPO | | |
| - l e | ВО | 05150143 | 06/18/93 | Japan (English Abstract only) | | |
| | BP | 2 779 843 | 12/17/99 | France | | xx |
| | BQ | 5-086477 | 04/06/93 | Japan (English Abstract only) | | |

SERIAL NO. ATTY DOCKET NO. Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE 248402US99DIV 10/767,994 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Jamai RAMDANI, et al. GROUP FILING DATE 2815 February 2, 2004 FOREIGN PATENT DOCUMENTS TRANSLATION DOCUMENT COUNTRY DATE NUMBER YES NO 07/26/77 52-89070 Japan CAA 01/17/01 EP 1 069 606 Europe CAB 01/10/02 WIPO CAC WO 02/03113 WIPO WO 02/03467 01/10/02 CAD EUROPE 0 630 057 12/21/94 CAE Japan w/English Abstract 02/21/86 61-36981 CAF WIPO CAG WO 93/07647 04/15/93 2002-9366 01/11/02 Japan w/English Abstract CAH 12/02/98 EP 0 881 669 Europe CAL WIPO WO 02/03480 01/10/02 CAJ WIPO 06/27/02 WO 02/50879 CAK CAL EP 0 777 379 06/04/97 Europe XX WO 01/04943 A1 01/18/01 WIPO CAM WIPO WO 02/47127 A2 06/13/02 CAN Japan w/English Abstract 05/07/83 CAO JP 58-075868 CAP EP 0 993 027 04/12/00 Europe EP 0 711 853 05/15/96 Europe CAQ 05/14/98 WIPO WO 98/20606 CAR EP 1 043 765 CAS 10/11/00 Europe 0 300 499 01/25/89 CAT Europe CAU EP 1 085 319 03/21/01 Europe CAV WO 01/16395 03/08/01 WIPO 12/19/00 Japan w/English Abstract 2000-351692 CAW 08/16/91 Japan (English Abstract only) 03-188619 CAX 11/28/88 Japan (English Abstract only) CAY 63-289812 CAZ EP 0 884 767 12/16/98 Europe 06-069490 03/11/94 Japan (English Abstract only) CBA 08/16/01 WIPO CBB WO 01/59821 A1 CBC CBD CBE CBF CBG СВН CBI CBJ CBK CBL СВМ CBN СВО CBP CBQ

| Form PTO 1449 | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | | | | |
|------------------------|---|---|---|--|--|--|--|--|--|
| (Modified) | PATENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | | | | |
| LIST OF REF | ERENCES CITED BY APPLICANT | APPLICANT Jamai RAMD | ANII ot al | | | | | | |
| LIST OF REI | ENERGES CITED BY AFFEICANT | FILING DATE | GROUP | | | | | | |
| | | February 2, 2004 | 2815 | | | | | | |
| | | 1 Coldary 2, 2004 | 2010 | | | | | | |
| | | (Including Author, Title, Date, Pertinent Pag | | | | | | | |
| CCAA | Nakagawara et al., "Effects of Buffer December 15, 1995, pp. 7226-7230. | Layers in Epitaxial Growth of SrTiO ₃ Thin Film | on Si(100), <i>J. Appl. Phys.,</i> 78 (12), | | | | | | |
| CCAB | Suzuki et al., "A Proposal of Epitaxia Engineering B41, (1996), pp. 166-17 | l Oxide Thin Film Structures For Future Oxide E 3. | Electronics," Materials Science and | | | | | | |
| CCAC | W. F. Egelhoff et al., "Optimizing GN Technology Conference, pp. 34-37. | IR Spin Valves: The Outlook for Improved Prop | erties", 1998 Int'l Non Volatile Memory | | | | | | |
| CCAD | Wang et al., "Processing and Perform May 11, 2000. | nance of Piezoelectric Films", Univ. Of MD, Wil | coxon Research Col, and Motorola Labs, | | | | | | |
| CCAE | M. Rotter et al., "Nonlinear Acoustoe August 16, 1999, pp. 965-967. | 1. Rotter et al., "Nonlinear Acoustoelectric Interactions in GaAs/LiNbO ₃ Structures", Applied Physics Letters, Vol. 75(7), ugust 16, 1999, pp. 965-967. | | | | | | | |
| CCAF | K. Sreenivas et al., "Surface Acousti Feb. 29, 1998, pp. 709-711. | c Wave Propagation on Lead Zirconate Titanate | e Thin Films," Appl. Phys. Lett. 52 (9), | | | | | | |
| CCAG | M. Rotter et al., "Single Chip Fused I Letters, Vol. 70(16), April 21, 1997, | Hybrids for Acousto-Electric and Acousto-Optic op. 2097-2099. | Applications," 1997 Applied Physics | | | | | | |
| CCAH | A. Mansingh et al., "Surface Acoustic Heterostructures," Ferroelectric, Vol. | : Wave Propagation in PZT/YBCO/SrTiO $_3$ and 224, pages 275-282, 1999. | PbTiO ₃ /YBCO/SrTiO ₃ Epitaxial | | | | | | |
| CCAI | S. Mathews et al., "Ferroelectric Field April 11, 1997, pp. 238-240. | Effect Transistor Based on Epitaxial Perovskii | e Heterostructures", Science, Vol. 276, | | | | | | |
| CCAJ | R. Houdre et al., "Properties of GaAs Issue 2, 1990, pp. 91-114. | on Si Grown by Molecular Beam Epitaxy," Soli | d State and Materials Sciences, Vol. 16, | | | | | | |
| CCAK | S. F. Fang et al., "Gallium Arsenide a 1990, pp. R31-R58. | and Other Compound Semiconductors on Silico | n," J. Appl. Phys., 68(7), October 1, | | | | | | |
| CCAL | Carlin et al., "Impact of GaAs Buffer Appl. Phys. Letter, Vol. 76, No. 14, A | Thickness on Electronic Quality of GaAs Grown pril 2000, pp. 1884-1886. | on Graded Ge/GeSi/Si Substrates, | | | | | | |
| CCAM | Ringel et al., "Epitaxial Integration of Symposium on Compound Semicono | III-V Materials and Devices with Si Using Grade luctors, Oct. 2000. | ed GeSi Buffers," 27 th International | | | | | | |
| CCAN | Zogg et al., "Progress in Compound- Soc., Vol. 136, No. 3, March 1998, pp | Semiconductor-on-Silicon-Heteroepitaxy with F p. 775-779. | uoride Buffer Layers," J. Electrochem | | | | | | |
| CCAO | Xiong et al., "Oxide Defined GaAs Ve Letters, Vol. 12, No. 2, Feb. 2000, pp | rtical-Cavity Surface-Emitting Lasers on Si Sub 110-112. | ostrates," IEEE Photonics Technology | | | | | | |
| CCAP | Clem et al., "Investigation of PZT//LS Res. Soc. Symp. Proc., Vol. 541, pp. | CO//Pt//Aerogel Thin Film Composites for Unco 661-666, 1999. | poled Pyroelectric IR Detectors," Mat. | | | | | | |
| CCAQ | Gunapala et al., "Bound-To-Quasi-Bo September 1998. | und Quantum-Well Infrared Photodetectors," N | ASA Tech Brief, Vol. 22, No. 9, | | | | | | |
| Examiner | | Date | Considered | | | | | | |
| Examiner: Initial if r | eference is considered, whether or not | citation is in conformance with MPEP 609; Dra | w line through citation if not in | | | | | | |
| | | with next communication to applicant | , = | | | | | | |

| (Modified) PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT LIST OF REFERENCES CITED BY APPLICANT FILING DATE February 2, 2004 10/767,994 APPLICANT Jamal RAMDANI, et al. FROUP February 2, 2004 2815 | |
|---|-------|
| LIST OF REFERENCES CITED BY APPLICANT Jamal RAMDANI, et al. FILING DATE GROUP | |
| FILING DATE GROUP | |
| 1.12.10 2.112 | |
| 1 Columny 2, 2007 | |
| | |
| OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) | |
| DDAA Abhay M. Joshi et al., "Monolithic InGaAs-on-silicon Wave Infrared Detector Arrays," Intn. Society for Optical Engineerin Vol. 2999, pp. 211-224. | ng, |
| DDAB Bruley et al., "Nanostructure and Chemistry of a (100)MgO/(100) GaAs Interface," Appl. Phys Lett, 65(5), Aug. 1994, pp 566. | . 564 |
| DDAC Fork et al., "Epitaxial MgO On Si(001) for Y-Ba-Cu-O Thin Film Growth by Pulsed Laser Deposition," Appl. Phys Lett., 5 May 20, 1991, pp. 2294-2296. | 8(20) |
| DDAD Himpsel et al., "Dialectrics on Semiconductors," Materials Science and Engineering, B1(1988), pp. 9-13. | |
| DDAE Li et al., "Epitaxial La _{0.67} Sr _{0.33} MnO ₃ Magnetic Tunnel Junctions," J. Appl. Phys. 81(8), Apr. 15, 1997, pp. 5509-5511. | |
| DDAF O'Donnell et al., "Colossal Magnetoresistance Magnetic Tunnel Junctions Grown by Molecular-Beam Epitaxy," Appl. Ph. Letters, Vol. 76, No. 14, April 3, 2000, pp. 1914-1916. | ysics |
| DDAG Mikami et al., "Formation of Si Epi/MgO-Al ₂ O ₃ Epi./SiO ₃ /Si and Its Epitaxial Film Quality," Fundamental Research Laboratories and Microelectronics Laboratories, pp. 31-34, 1983. | |
| DDAH T. Asano et al., "An Epitaxial Si/Insulator/Si Structure Prepared by Vacuum Deposition of CaF ₂ and Silicon," <i>Thin Solid</i> IVol. 93 (1982), pp. 143-150. | Films |
| DDAI T. Chikyow et al., "Reaction and Regrowth Control of CeO₂ on Si(111) Surface for the Silicon-On-Insulator Structure," A Phys. Lett., Vol. 65, No. 8, 22 August 1994, pp. 1030-1032. | ppl. |
| DDAJ J.F. Kang, et al., "Epitaxial Growth of CeO₂(100) Films on Si(100) Substrates by Dual Ion Beams Reactive Sputtering," State Communications, Vol. 108, No. 4, pp. 225-227, 1998. | Solid |
| DDAK R.A. Morgan et al., "Vertical-Cavity Surface-Emitting Lasers Come of Age," SPIE, Vol. 2683, pp. 18-29. | |
| DDAL "Technical Analysis of Qualcomm QCP-800 Portable Cellular Phone (Transmitter Circuitry)," Talus Corporation, Qualco QCP-800 Technical Analysis Report, December 10, 1996, pp. 5-8. | mm |
| DDAMJo-Ey WONG, et al.; "AN ELECTROSTATICALLY-ACTUATED MEMS SWITCH FOR POWER APPLICATIONS"; IEEE 2000; pp. 633-638 | • |
| DDAN T. MIZUNO, et al.; "Electron and Hole Mobility Enhancement in Strained-Si MOSFET's on SiGe-on-Insulator Substrates Fabricated by SIMOX Technology"; IEEE ELECTRON DEVICE LETTERS, VOL. 21. NO. 5, MAY 2000; pp. 230-232 | 3 |
| DDAO F.M. BUFFER, et al.; "Strain-dependence of electron transport in bulk Si and deep-submicron MOSFET's" Computatura Electronics, 2000, Book of Abstracts, IWCE Glasgow 2000, 7 th Int'l Workshop on, 2000; pp. 64-65 | al |
| DDAP S.S. LU, et al.; "Piezoelectric field effect transistor (PEFET) using In _{0.2} Ga _{0.8} As/Al _{0.35} Ga _{0.65} As/In _{0.2} Ga _{0.8} As/GaAs Straine layer structure on (111)B GaAs substrate"; ELECTRONICS LETTERS, 12 TH Ma 1994, Vol. 30, No. 10; pp. 823-825 | d |
| DDAQ Kihong KIM, et al." On-Chip Wireless Interconnection with Integrated Antennas"; 2000 IEEE; pp. 20.2.1-20.3.4 | |
| Examiner Date Considered | |
| *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | |

| Form PTO 1449 | | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | |
|---------------|-------------|---|--|--|--|--|--|
| (Modified) | PA | ATENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | |
| | | | APPLICANT | | | | |
| LIST OF | REFER | RENCES CITED BY APPLICANT | Jamal RAMDANI | | | | |
| | | • | FILING DATE February 2, 2004 | GROUP 2815 | | | |
| | | | 1 ebidary 2, 2004 | 2010 | | | |
| | | | Including Author, Title, Date, Pertinent Pages, e | | | | |
| | EEAA | | O SINGLE CHIP, DIRECT CARRIER BPSK MODU 1998 IEEE MTT-S DIGEST; pp. 305-308 | LATION TRANSMITTER WITH | | | |
| | EEAB | Mau-Chung Frank CHANG, et al.; "RI IEEE, Vol. 89, No. 4, April 2001; pp. 4 | F/Wireless Interconnect for Inter- and Intra-Chip Co 456-466 | ommunications"; Proceedings of the | | | |
| | EEAC | The Electronics Industry Report; Pris | mark; 2001; pp. 111-120 | | | | |
| | EEAD | J.K. ABROKWAH, et al.; "A Manufac | turable Complementary GaAs Process"; GaAs IC S | Symposium, IEEE, 1993; pp. 127-130 | | | |
| | EEAE | H. Nagata, "A Preliminary Considerat Solid Films, 224, 1993, pp. 1-3. | tion of the Growth Behaviour of CeO ₂ , SrTiO ₃ and S | SrVO ₃ Films on Si Substrate," Thin | | | |
| | | | n of $CeO_2(001)$ Films on Si(001) Substrates by Puls . 30, No. 6B, June 1991, pp. L1136-L1138. | sed Laser Deposition in Ultrahigh | | | |
| | EEAG | Kado et al., "Heteroepitaxial Growth o | of SrO Films on Si Substrates," J. Appl. Phys., 61(6 | s), March 15, 1987, pp. 2398-2400. | | | |
| | EEAH | H. Ishiwara et al., "Epitaxial Growth of Perovskite Type Oxide Films on Substrates"; Materials Research Symposium Proceedings, Vol. 220, pp. 595-600, April 29 - May 3, 1991. | | | | | |
| | EEAI | | able High-Speed Low-Power Complementary GaAs lid State Devices and Materials, Yokohama, 1994, | | | | |
| | EEAJ | C.J. Palmstrom et al.; "Stable and E Fundamentals and Technology; Noyl | pitaxial Contacts to III-V Compound Semiconductores Publications, 1993; pp.67-150 | rs"; Contacts to Semiconductors | | | |
| | | | omicron three-dimensional infrared GaAs/Al $_{ m x}$ O $_{ m y}$ -bas S LETTERS, VOLUME 78, NUMBER 20, 14 MAY 2 | | | | |
| | EEAL | Philip BALL; "The Next Generation of | Optical Fibers"; Technology Review, May 2001; pp | o.55-61 | | | |
| | EEAM | John D. JOANNOPOULOS, et al.; "M | lolding the Flow of Light"; Photonic Crystals; Prince | ton University Press, 1995 | | | |
| | | Thomas F. KRAUSS, et al.; "Photonic Electronics 23 (1999) 51-96 | c crystals in the optical regime - past, present and | future"; Progress in Quantum | | | |
| | EEAO | G. H. JIN, et al.; "PLZT Film Wavegu No. 6. June 2000; pp.807-812 | ide Mach-Zehnder Electrooptic Modulator"; Journal | of Lightwave Technology, Vol. 18, | | | |
| | EEAP | 5 = 1051/50 1 1 101 (001) | No. 11. Annual Control of the Contro | 1- 4 Juliana 4007: 020 044 | | | |
| | EEAQ | |) silicon surfaces"; J. Vac. Sci. Technol. B, Vol. 5, N field effect transistor"; APPLIED PHYSICS LETTER | | | | |
| Examiner | | • | Date Con | sidered | | | |
| *Examiner: In | itial if re | eference is considered, whether or not | l t citation is in conformance with MPEP 609; Draw li | ne through citation if not in | | | |
| | | | with next communication to applicant. | | | | |

| Form PTO 1449 | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | | |
|---|---|--|-------------------------------------|--|--|--|--|
| (Modified) | PATENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | | |
| | | APPLICANT | | | | | |
| LIST OF RE | FERENCES CITED BY APPLICANT | Jamal RAMDANI, | | | | | |
| | | FILING DATE | GROUP | | | | |
| | | February 2, 2004 | 2815 | | | | |
| | OTHER REFERENCES | (Including Author, Title, Date, Pertinent Pages, e | etc.) | | | | |
| JFF. | AA Lucent Technologies, Inc. "Arrayed V | Vaveguide Grating Multiplexer/Demultiplexer"; Janu | ary 2000; 4 pages | | | | |
| | , | | | | | | |
| | AB Hisashi SHICHLIO et al : "Co-Integra | tion of GaAs MESFET and Si CMOS Circuits": IEE | E ELECTRON DEVICE LETTERS. | | | | |
| | FAB Hisashi SHICHIJO, et al.; "Co-Integration of GaAs MESFET and Si CMOS Circuits"; IEEE ELECTRON DEVICE LETTERS, VOL. 9, NO. 9, SEPTEMBER 1988; pp.444-446 | | | | | | |
| <u> </u> | AC LI SUICHIO et al : "CaAa MESSETT | and Si CMOS Cointegration and Circuit Technique | e": 1988 IEEE: GaAs IC Symposium | | | | |
| | AC H. SHICHIJO, et al.; "GaAS MESFET | and of Civico Connegration and Circuit recrinique | o , 1000 IEEE, Gans 10 Gymposium | | | | |
| | | | 770 704 | | | | |
| FF | AD H. SHICHIJO, et al.; "Monolithic Proc | ess for Co-Integration of GaAs and Silicon Circuits | ; 1988 IEEE; pp.//8-/81 | | | | |
| | | | | | | | |
| FF | AE Z.H. ZHU, et al. "Growth of InGaAs m | nulti-quantum wells at 1.3 m wavelength on GaAs c | ompliant substrates"; APPLIED | | | | |
| | PHYSICS LETTERS, VOLUME 72, N | IUMBER 20, 18 MAY 1998; pp.2598-2600 | | | | | |
| FF | | phic InAlAs/InGaAs Enhancement Mode HEMT's o | n GaAs Substrates"; IEEE | | | | |
|] | ELECTRON DEVICE LETTERS, VO | L. 20, NO. 10, OCTOBER 1999; pp.507-509 | | | | | |
| FF | AG Tomonori NAGASHIMA, et al.: "Three | e-Terminal Tandem Solar Cells With a Back-Conta | ct Type Bottom Cell" Higashifuji | | | | |
| [| Technical Center, Toyota Motor Corp | | | | | | |
| | FFAH James SCHELLENBERG, et al.; "Low-Loss, Planar Monolithic Baluns for K/Ka-Band Applications"; 1999 IEEE MTT-S | | | | | | |
| | Digest; pp.1733-1736 | T LOCO, Flatial Monolinino Dalutio for Forta Dalid Ap | | | | | |
| | All Annual Later and the Province Later Co. | eposition of Superconducting Strontium Titanate Th | in-Filme": • Session K11-Thin Films | | | | |
| FF | Arnold Leitner et al; "Pulsed Laser De and Borocarbides; Mixed Session, W | eposition of Superconducting Strontium Titanate Tr ednesday Afternoon; March 19 1997; Room 1202 I | B, Conv. Center (Abstract) | | | | |
| | | | | | | | |
| FF | AJ R.D. VISPUTE; "High quality optoele Thin Solid Films 299 (1997), pp.94-1 | ctronic grade epitaxial AIN films on $-Al_2O_3$, Si and 6 | bH-SIC by pulsed laser deposition"; | | | | |
| | | | | | | | |
| FF | AK T. Warren WEEKS, et al.; "GaN thin | films deposited via organometallic vapor phase epi fer layers" 320 Applied Physics Letters, Vol. 67, No | taxy on (6H)-SiC(0001) using high- | | | | |
| | | | | | | | |
| FF | AL Z. YU, et al.; "Epitaxial oxide thin film | s on SI(001)*"; J. Vac. Sci. Technol. B. Vol. 18, No | . 4, Jul/Aug 2000; pp.2139-2145 | | | | |
| | | | | | | | |
| FF | AM Gentex Corporate Website; "Photoele | ectric Smoke Detectors - How They Work; 2001 | | | | | |
| | | | • | | | | |
| FF | AN Leffrey B. Casady, et al.: "A Hybrid 6 | H-SiC Temperature Sensor Operational from 25 C | to 500 C"; IEEE TRANSACTIONS | | | | |
| ' | ON COMPONENTS, PACKAGING, | AND MANUFACTURING TECHNOLOGY - PART A | A, VOL. 19, NO. 3, SEPTEMBER | | | | |
| | 1996; pp. 416-422 | ELECTRONIC INTEGRATED CIRCUITS"; ELECT | RO-OPTICS HANDROOK McGraw- | | | | |
| | Hill, Inc., 1994; Chapter Twenty Seve | en | | | | | |
| | | | huada": Ontice 9 Dhatanias Nove: | | | | |
| FFAP Antonio MECOZZI, et al.; "The Roles of Semiconductor Optical Amplifiers in Optical Networks"; Optics & Photonics News March 2001; pp. 37-42 | | | | | | | |
| | | | | | | | |
| FFAQ D.A. FRANCIS, et al.; "A single-chip linear optical amplifier"; OFC, 2001; March 17-22, 2001 | | | | | | | |
| | | · | | | | | |
| Examiner | | Date Cor | nsidered | | | | |
| *Examiner: Initial | if reference is considered, whether or no | t citation is in conformance with MPEP 609; Draw li | ne through citation if not in | | | | |
| | t not considered. Include copy of this form | | | | | | |

| Form PTO 1449 | | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | |
|---------------|-------|--|--|--|--|--|--|
| (Modified) | PA | TENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | |
| LICTOF | | | APPLICANT | | | | |
| LIST OF | KEFER | RENCES CITED BY APPLICANT | FILING DATE | MDANI, et al. GROUP | | | |
| | | | February 2, 2004 | 2815 | | | |
| | , | | | | | | |
| | IGGAA | | including Author, Title, Date, Pertinent F of cintl-phase Ca(Si1-xGex)2"; Journal of C | | | | |
| • | | O. Vogg et al., Epitaxial alloy lilins | s of Zinu-phase Ca(Si1-xGex)2 , Journal of C | rystat Growth 223 (2001), pp. 575-576 | | | |
| -, | GGAB | Poter S. CI III FOVI F. et al : "Onto | electronic Architecture for High-Speed Switch | hing and Processing Applications": 1009 Th | | | |
| | GOAD | Photonics Design and Applications | | ring and Processing Applications, 1996 11 | | | |
| | CCAC | Corold D. STDINGEELL OW! #O | The state of the s | d Desertion P. Desertion and a filtration | | | |
| | GGAC | Science and Engineering and Elec | anometallic Vapor-Phase Epitaxy: Theory an trical Engineering, University of Utah; Acade | nd Practice;; Departments of Materials mic Press, 1989 | | | |
| | GGAD | AD M.A. HERMAN, et al.; "Molecular Beam Epitaxy Fundamentals and Current Status"; Springer-Verlag Berlin Heidelb 1989, 1996 | | | | | |
| | GGAE | "Integration of GaAs on Si Using a | Spinel Buffer Layer", IBM Technical Bulletin, | Vol. 30, No. 6, Nov. 1987, p. 365. | | | |
| | | | | | | | |
| | GGAF | "GalnAs Superconducting FET," IB | BM Technical Bulletin, Vol. 36, No. 8, Aug. 19 | 93, p. 655-656. | | | |
| | | İ | | | | | |
| | GGAG | "Epitaxial 3d Structure Using Mixed | Spinels," IBM Technical Bulletin, Vol. 30, No. | o. 3, Aug. 1987, p. 1271. | | | |
| | | · · | | | | | |
| | GGAH | Moon et al., "Roles of Buffer Layers 33, March 1994, pp. 1472-1477. | s in Epitaxial Growth of SrTiO ₃ Films on Silico | on Substrates," Japan J of Appl. Phys., Vol. | | | |
| • | GGAI | Yodo et al., GaAs Heteroepitaxial (| Growth on Si Substrates with Thin Si Interlaye | ers in situ Annealed at High Temperatures. | | | |
| | | | & Technology, 1995 May/June, Vol. 13, No. | | | | |
| | GGAJ | Cuomo et al., "Substrate Effect on | the Superconductivity of YBa ₂ Cu ₃ O ₇ Thin Fil | ms." AIP Conference 1988, pp. 141-148. | | | |
| | | | , | , | | | |
| | GGAK | McKee et al "Crystalline Oxides o | n Silicon: The First Five Monolayers," Physic | al Review Letters. Vol. 81. No. 14. Oct. | | | |
| | | 1998, pp. 3014-3017. | | | | | |
| | GGAL | McKee et al "Molecular Beam Epi | taxy Growth of Epitaxial Barium Silicide, Bari | ium Oxide, and Barium Titanate on Silicon." | | | |
| | | 1991 American Institute of Physics | | , | | | |
| | GGAM | Tambo et al., Molecular Beam Epit | axy Growth of SrTiO ₃ Films on Si(100)-2x1 w | vith SrO Buffer Laver." Jon. J. Apol. Phys. | | | |
| | | Vol. 37, 1998, pp. 4454-4459. | | ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,, | | | |
| | GGAN | McKee et al "The MBE Growth an | d Optical Quality of BaTiO ₃ and SrTiO ₃ Thin | Films on MgO." Mat. Res. Soc. Symp. | | | |
| | | Proc., Vol. 341, April 1994, pp. 309 | | | | | |
| | GGAO | McKee et al., "BaSi2 and Thin Film | Alkaline Earth Silicides on Silicon," Appl. Ph | vs. Lett. 63 (20). Nov. 1993, pp. 2818-2820 | | | |
| | | | | , or assume as (20), the second pp. 2010 2010 | | | |
| | GGAP | McKee et al "Surface Structures a | and the Orthorhombic Transformation of Thin | Film BaSi₂ on Silicon." Mat. Res. Soc. | | | |
| | | Symp. Proc., Vol. 221, pp. 131-136 | | | | | |
| | GGAQ | Brian A. FLOYD, et al.: "The project | ted Power Consumption of a Wireless Clock | Distribution System and Comparison to | | | |
| | | | ; IEEE, 1999; pp. IITC99-249-IITC99-250 | | | | |
| | | | | | | | |
| xaminer | | <u> </u> | lDa | ate Considered | | | |

| | | | | | | | | | |
|----------------|------------|--|---|---|--|--|--|--|--|
| Form PTO 1449 | | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | | | |
| (Modified) | PA | TENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | | | |
| _ | | | APPLICANT | | | | | | |
| LIST OF | KEFEF | RENCES CITED BY APPLICANT | Jamai RAMDANI | , et al. GROUP | | | | | |
| | | | FILING DATE February 2, 2004 | 2815 | | | | | |
| <u> </u> | | | Febluary 2, 2004 | 2013 | | | | | |
| | | OTHER REFERENCES (| Including Author, Title, Date, Pertinent Pages, e | etc.) | | | | | |
| | | Mori et al., "Epitaxial Growth of SrTiO <i>Jpn. J. of Apl. Phy</i> s., Vol. 30, No. 8A, | 3 Films on Si(100) Substrates Using a Focused Ele Aug. 1991, pp. L1415-L1417. | ectron Beam Evaporation Method," | | | | | |
| | ннав | Moon et al., "Growth of Crystalline Sr Properties," <i>Jpn. J. of Appl. Phys.</i> , Vo | Moon et al., "Growth of Crystalline SrTiO ₃ Films on Si Substrates Using Thin Fluoride Buffer Layers and Their Electrical Properties," <i>Jpn. J. of Appl. Phys.</i> , Vol. 33, (1994), pp. 5911-5916. | | | | | | |
| | | Farrow et al., "Heteroepitaxy of Dissir May 2, 1991. | nilar Materials," Mat. Res. Soc. Symposium Procee | edings, Vol. 221, pp. 29-34, April 29 - | | | | | |
| | HHAD | lshiwara et al., "Heteroepitaxy on Silic Vol. 116, pp. 369-374, April 5-8, 1988 | con: Fundamentals, Structure, and Devices," <i>Mat. I</i> b. | Res. Soc., Symposium Proceedings, | | | | | |
| | HHAE | Douglas B. Chrisey, et al; Pulsed Las | er Deposition of Thin Films; pp. 273-285 | | | | | | |
| | | B.A. Block, et al; "Photoluminescence 25-27 | e properties of Er ³ -doped BaTiO ₃ thin films"; Appl. I | Phys. Lett. 65 (1), 4 July 1994, pp. | | | | | |
| | HHAG | Kevin J. Chen et al; "A Novel Ultrafas Devices Meetingk 1996; IEEE Hong F | t Functional Device: Resonant Tunneling High Ele Kong; June 29, 1996; pp. 60-63, XP010210167 | ctron Mobility Transistor"; Electron | | | | | |
| | | HAH Wenhua Zhu et al.; "Molecular Beam Epitaxy of GaAs on Si-on-Insulator"; 320 Applied Physics Letters 59(1991) 8 July 2; pp. 210-212 | | | | | | | |
| | | | Compound Semiconductor Electronics*; Electron C.; 7-10 December 1997; pp. 545-548 | Devices Meeting; 1997; Technical | | | | | |
| | HHAJ | J.M. Daughton et al.; "Applications of | Spin Dependent Transport Materials"; J. Phys. D. | Appl. Phys. 32(1999) R169-R177 | | | | | |
| | HHAK | Wei Zhang et al.; "Stress Effect and I Condensed Matter; American Institute | Enhanced Magnetoresistance in La _{0.67} Ca _{0.33} MnO ₃₋ e of Physics; Vol. 58, No. 21, Part 1; December 1, | _s Films"; Physical Review, B. 1998; pp. 14143-14146 | | | | | |
| | HHAL | QY. Tong et al.; "IOS-a new type of Conference, Oct. 1999; pp.104-105 | materials combination for system-on-a chip prepar | ation": 1999 IEEE International SOI | | | | | |
| | | Electrochemical Society Proceedings | ctric 1hfo2/Ta205 Thin Film Nanolaminate Capacit , U.S. Electrochemical Society; Pennington, N.J.; A | August 31, 1997; pp. 36-46 | | | | | |
| | | 13, 1995; pp. 1331-1333 | wth of BaTio₃ Films on Si by Pulsed Laser Deposit | | | | | | |
| | | Applied Physics Letters; Vol. 34; 199 | | • | | | | | |
| | | and Technology Conference; pp. 1-4 | uracy Machine Automated Assembly for Opto Elec | | | | | | |
| | HHAQ | R. Ramesh; "Ferroelectric La-Sr-Co-0 Applied Physics Letters; 63(1993); 27 | D/Pb-Zr-Ti-O/La-Sr-Co-O Heterostructures on Silic December; No. 26; pp. 3592-3594 | on via Template Growth"; 320 | | | | | |
| Examiner | <u> </u> | | Date Cor | nsidered | | | | | |
| *Examiner: Ini | tial if re | ference is considered, whether or not | citation is in conformance with MPEP 609; Draw I | ne through citation if not in | | | | | |
| conformance | and not | considered. Include copy of this form | with next communication to applicant. | | | | | | |

| Form PTO 1449 | | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | | |
|-----------------|-----------|---|---|---|--|--|--|--|
| (Modified) | P | ATENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | | |
| | | | APPLICANT | II at al | | | | |
| LIST OF | REFE | RENCES CITED BY APPLICANT | Jamal RAMDAN | GROUP | | | | |
| | | | FILING DATE February 2, 2004 | 2815 | | | | |
| | | | , 33,22, 2, 232 | | | | | |
| | | OTHER REFERENCES | (Including Author, Title, Date, Pertinent Pages fors with SrTiO ₃ Gate Dielectric on Si"; Applied Ph | etc.) | | | | |
| | IIAA | 6, 2000; pp. 1324-1326 | ors with 31 1103 Gate Dielectric on 31, Applied 1 11 | ysics Ecitors, Vol. 70, 140. 10, March | | | | |
| | IIAB | Stephen A. Mass; "Microwave Mixers | s"; Second Edition; 2pp. | | | | | |
| | IIAC | Douglas J. Hamilton et al.; "Basic Int | Douglas J. Hamilton et al.; "Basic Integrated Circuit Engineering"; pp.2; 1975 | | | | | |
| | IIAD | | esistance at Up to 270 K in La _{0.8} Sr _{0.2} MnO ₃ /SrTiO Letters; Vol. 74, No. 2; 11 January 1999; pp. 290- | | | | | |
| | IIAE | | oresistance in La-Ca-Mn-O Films on Si Substrate 32-287, No. 2003; 1 August 1997; pp. 1231-1232 | es Using YbaCuO/CeO ₂ | | | | |
| | IIAF | Shogo Imada et al; "Epitaxial Growth Jpn. J. Appl. Phys. Vol. 37 (1998); pp | of Ferroelectric YmnO ₃ Thin Films on Si (111) St b. 6497-6501; Part 1, No. 12A, December 1998 | ibstrates by Molecular Beam Epitaxy"; | | | | |
| | IIAG | | Dependence of the Magnetization Reversal in Co(1 No. 8; 15 April 1999; pp. 5765-5767 | cc)-BN-Co(poly hcp) Structures"; | | | | |
| | IIAH | C. Martinez; "Epitaxial Metallic Nano | ostructures on GaAs"; Surface Science; Vol. 482- | 185; pp. 910-915; 2001 | | | | |
| | IIAI | Wen-Ching Shih et al.; "Theoretical Transactions of Ultrasonics, Ferroel | Investigation of the SAW Properties of Ferroelect ectrics, and Frequency Control; Vol. 45, No. 2; March 2015. | ric Film Composite Structures"; IEEE arch 1998; pp. 305-316 | | | | |
| | IIAJ | Zhu Dazhong et al.; "Design of ZnO International Conference on Solid-S | /SiO ₂ /Si Monolithic Integrated Programmable SA\ tate and Integrated Circuit Technology; 21-23; Oc | N Filter"; Proceedings of Fifth tober 1998; pp. 826-829 | | | | |
| | IIAK | Kirk-Othmer Encyclopedia of Chemic Interscience Publication; John Wiley | al Technology; Fourth Edition, Vol. 12; Fuel Reso & Sons | urces to Heat Stabilizers; A Wiley- | | | | |
| | IIAL | Joseph W. Goodman et al; "Optical I | nterconnections For VLSI Systems*; Proceedings | of the IEEE, Vol. 72, No. 7 July 1984 | | | | |
| | IIAM | SUBSTRATE"; Fourth International 1992; pp. 167-170; XP000341253; | FEGRATION OF InGaAs/InAlAs MODFETs and F Conference on Indium Phosphide and Related M IEEE, New York, NY, USA; ISBN: 0-7803-0522-1 | aterials, Newport, RI, USA; April 21-24 | | | | |
| | IIAN | H. Takahashi et al.; "Arraryed-Wave REsolution"; Electronics Letters; Vo | guide Grating For Wavelength Division Multi/Den | nultiplexer With Nanometre | | | | |
| | IIAO | Pierret, R.F.; "1/J-FET and MESFET" | '; Field Effect Devices; MA, Addison-Wesley; 199 | 0; pp. 9-22 | | | | |
| | IIAP | M. Schreiter, et al.; "Sputtering of Sel | If-Polarized PZT Films for IR-Detector Arrays"; 19 | 98 IEEE; pp. 181-185 | | | | |
| | IIAQ | Hideaki Adachi et al.; "Sputtering Pre Transactions of Ultrasonics, Ferroele | paration of Ferroelectric PLZT Thin Films and Th ctrics and Frequency Control, Vol. 38, No. 6, Nov | eir Optical Applications"; IEEE ember 1991 | | | | |
| Examiner I | | 1 | Date Co | onsidered | | | | |
| *Examiner: Init | ial if re | eference is considered, whether or not | citation is in conformance with MPEP 609; Draw with next communication to applicant. | line through citation if not in | | | | |

| | ALC DEPLOTHENT OF CO | ATTY DOCKET NO | SERIAL NO | | | | | |
|-------------------------------|---|---|---------------------------------------|--|--|--|--|--|
| Form PTO 1449 (Modified) P | U.S. DEPARTMENT OF COMMERCE ATENT AND TRADEMARK OFFICE | ATTY DOCKET NO. 248402US99DIV | SERIAL NO. 10/767,994 | | | | | |
| LIST OF BEEF | DENICES CITED BY ADDITIONAL | APPLICANT | | | | | | |
| LIST OF KEFE | RENCES CITED BY APPLICANT | Jamai RAMDANI, | | | | | | |
| | | Filing DATE February 2, 2004 | GROUP 2815 | | | | | |
| | | | | | | | | |
| | | (Including Author, Title, Date, Pertinent Pages, e | | | | | | |
| JUAA | A.J. Moulson et al.; "Electroceramics | Materials Properties Applications"; Chapman & Ha | II, pp. 300-309 | | | | | |
| JJAB | | P.A. Langjahr et al.; "Epitaxial Growth and Structure of Cubic and Pseudocubic Perovskite Films on Perovskite Substrates"; Mat. Res. Soc. Symp. Proc., Vol. 401; 1995 Materials Research Society; pp. 109-114 | | | | | | |
| JJAC | Wang et al.; "Deplation-Mode GaAs I 1998, IEDM '98 Technical Digest; pp | MOSFETs with Negligible Drain Current Drift and H . 67-70 | ysteresis"; Electron Devices Meeting, | | | | | |
| JJAD | Ben G. Streetman; "Solid State Elect | ronic Devices"; 1990, Prentice Hall; Third Edition; p | p. 320-322 | | | | | |
| JJAE | A.Y Wu et al.; "Highly Oriented (Pb,L | a)(Zr,Ti)O ₃ Thin Films on Amorphous Substrates"; | IEEE, 1992; pp. 301-304 | | | | | |
| JJAF | JJAF Timothy E. Glassman et al.; "Evidence for Cooperative Oxidation of MoCVD Precursors Used in Ba _x Sr _{1-x} TiO ₃ Film Grow Mat. Res. Soc. Symp. Proc. Vol. 446, 1997 Materials Research Society; pp. 321-326 | | | | | | | |
| | JJAG S.N. Subbarao et al.; "Monolithic PIN Photodetector and FET Amplifier on GaAs-os-Si"; IEEE; GaAs IC Symposium-163-166; 1989 | | | | | | | |
| JJAH | T.A. Langdo et al.; "High Quality Ge on Si by Epitaxial Necking"; Applied Physics Letters; Vol. 76, No. 25; pp. 3700-3702; June 19, 2000 | | | | | | | |
| JJAI | Chenning Hu et al.; Solar Cells From Basics to Advanced Systems; McGraw-Hill Book Company; 1983 | | | | | | | |
| JJAJ | O.J. Painter et al; "Room Temperature Photonic Crystal Defect Lasers at Near-Infrared Wavelengths in InGaAsp"; Journal of Lightwave Technology, Vol. 17, No. 11; November 1999 | | | | | | | |
| JJAK | C. Donn et al.; "A 16-Element, K-Bar International Symposium, 1988; pp.1 | nd Monolithic Active Receive Phased Array Antenna 88-191, Vol. 1; 6-10 June 1988 | "; Antennas and Propagation Society | | | | | |
| JJAL | Don W. Shaw; "Epitaxial GaAs on Si | : Progress and Potential Applications"; Mat. Res. S | Soc. Symp. Proc.; pp.15-30; 1987 | | | | | |
| JJAM | Symposium on Integrated Ferroelec | | | | | | | |
| JJAN | P.J. Borrelli et al.; "Compositional and Structural Properties of Sputtered PLZT Thin Films"; Ferroelectric Thin Films II Symposium; Dec. 2-4, 1991 (Abstract) | | | | | | | |
| JJAO | heterostructure"; 1 November 2000; | sto-optic diffraction efficiency in a symmetric SrRiO Vol. 39, No. 31; Applied Optics; pp. 5847-5853 | | | | | | |
| JJAP | Phys. D: Appl. Phys. 32 (1999) 380 | · | | | | | | |
| DACU | S.K. Tewksbury et al.; "Cointegration Proceedings, Fifth Annual IEEE; 20 | of Optoelectronics and Submicron CMOS"; Wafer January 1993; pp. 358-367 | Scale Integration; 1993; | | | | | |
| Examiner | | Date Cor | sidered | | | | | |
| *Examiner: Initial if re | eference is considered, whether or not | t citation is in conformance with MPEP 609; Draw ling with next communication to applicant. | ne through citation if not in | | | | | |
| Contonnance and the | considered, moidde copy of this form | to community approxim | | | | | | |

| Form PTO 1449 | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | | |
|--------------------|--|--|--|--|--|--|--|
| (Modified) Pa | ATENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | | |
| | | APPLICANT | | | | | |
| LIST OF REFE | RENCES CITED BY APPLICANT | Jamal RAMI | | | | | |
| | | FILING DATE | GROUP | | | | |
| | | February 2, 2004 | 2815 | | | | |
| | OTHER REFERENCES | (Including Author, Title, Date, Pertinent Pa | ges, etc.) | | | | |
| KKAA | V. Kaushik et al.; "Device Characteric Conference Digest 58th DRC; pp. 17 | stics of Crystalline Epitaxial Oxides on Silicon -20; June 19-21, 2000 | ; Device Research Conference, 2000; | | | | |
| ККАВ | Katherine Derbyshire; "Prospects Bright for Optoelectronics Volume, Cost Drive Manufacturing for Optical Applications"; Semiconductor Magazine; Vol. 3, No. 3; March 2002 | | | | | | |
| KKAC | Alex Chediak et al; "Integration of Ga MSE 225, April 12, 2002; pp. 1-5 | Nex Chediak et al; "Integration of GaAs/Si with Buffer Layers and Its Impact on Device Integration"; TICS 4, Prof. Sands. ## ASE 225, April 12, 2002; pp. 1-5 | | | | | |
| KKAD | S.A. Chambers et al; "Band Discontii No. 11; September 11, 2000; pp. 166 | nuities at Epitaxial SrTiO3/Si(001) Heterojunct 2-1664 | tions"; Applied Physics Letters; Vol. 77, | | | | |
| KKAE | KKAE H. Wang et al.; "GaAs/GaAlAs Power HBTs for Mobile Communications"; Microwave Symposium Digest; 1993 IEEE; Vol. pp. 549-552 | | | | | | |
| | AF Y. Ota et al.; "Application of Heterojunction FET to Power Amplifier for Cellular Telephone"; Electronics Letters; 26th May 1994; Vol. 30, No. 11; pp. 906-907 | | | | | | |
| KKAG | Keiichi Sakuno et al; "A 3.5W HBT MMIC Power Amplifier Module for Mobile Communications"; IEEE 1994; Microwave and Millimeter-Wave Monolithic Circuits Symposium; pp. 63-66 | | | | | | |
| KKAH | Mitsubishi Semiconductors Press Re | lease (GaAs FET's) November 8, 1999 pp.1-2 | 2 | | | | |
| KKAI | R.J. Matyi et al; "Selected Area Hete Films; 181 (1989) December 10; No. | roepitaxial Growth of GaAs on Silicon for Adv 1; pp. 213-225 | anced Device Structures"; 2194 Thin Solid | | | | |
| KKAJ | K. Nashimoto et al; "Patterning of Nb Phase Epitaxy"; Applied Physics Lett | , LaOnZr, TiO3 Waveguides for Fabricating Ners; Vol. 75, No. 8; 23 August 1999; pp. 1054 | Aicro-Optics Using Wet Etching and Solid- -1056 | | | | |
| KKAK | Bang-Hung Tsao et al; "Sputtered Ba Applications of Ferroelectrics, 2000; | rium Titanate and Barium Strontium Titanate Proceedings of the 2000 12th International Sy | Films for Capacitor Applications"; mposium on Vol. 2; pp. 837-840 | | | | |
| | Materials Research; Vol. 12, No. 5; p | | | | | | |
| KKAM | KKAM Yuji Matsumoto et al.; "Room-Temperature Ferromagnetism in Transparent Transition Metal-Doped Titanium Dioxide"; Science; 2 February 2001; Vol. 291; pp. 854-856 | | | | | | |
| KKAN | (AN S.A. Chambers et al.; "Epitaxial Growth and Properties of Ferromagnetic Co-Doped TiO2 Anatase"; Applied Physics Letters; Vol. 79, No. 21; November 19, 2001; pp. 3467-3469 | | | | | | |
| KKAO | | | | | | | |
| KKAP | | | | | | | |
| KKAQ | | | | | | | |
| Examiner | 1 | Dat | e Considered | | | | |
| | oforonce is considered whether or not | citation is in conformance with MPEP 609; C | Draw line through citation if not in | | | | |
| conformance and no | t considered, include copy of this form | with next communication to applicant. | | | | | |

SHEET 1 OF

5

SERIAL NO. ATTY DOCKET NO. U.S. DEPARTMENT OF COMMERCE Form PTO 1449 (Modified) PATENT AND TRADEMARK OFFICE 248402US99DIV 10/767,994 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Jamal RAMDANI, et al. GROUP -FILING DATE 2815 February 2, 2004 **U.S. PATENT DOCUMENTS** DOCUMENT SUB **FILING DATE EXAMINER CLASS** DATE NAME **CLASS** IF APPROPRIATE INITIAL NUMBER 06/18/96 Macdonald et al. UT 5,528,209 5,998,781 12/07/99 Vawter et al. UV UW 08/29/00 Ota et al. 6,110,813 09/17/02 UX 6,452,232 B1 Adan 04/11/00 Koh UY 6,049,110 09/24/96 Hu et al. UΖ 5,559,368 VA 6,392,253 B1 05/21/02 Saxena VΒ 5,585,288 12/17/96 Davis et al. 12/07/93 Vernon VC 5,268,327 VD 6,198,119 B1 03/06/01 Nabatame et al. 09/05/00 Miyata et al. VΕ 6,113,225 11/16/93 Grudkowski et al. VF 5,262,659 6,239,012 B1 05/29/01 Kinsman VG 10/02/01 Wang et al. 6,297,598 VH 10/03/02 Droopad VΙ 2002/140012 4,866,489 09/12/89 Yokogawa et al. VJ 06/27/00 Yokota et al. VK 6,080,378 04/16/96 Takatani et al. 5,508,554 ٧L 11/05/02 Shanley VM 6,477,285 B1 09/22/87 VN 4,695,120 Holder 03/16/99 Jewell VO 5,882,948 11/12/96 Feuer et al. VΡ 5,574,589 04/23/96 Conley VQ 5,510,665 VR 4,804,866 02/14/89 Akiyama 5,057,694 10/15/91 Idaka et al. vs 06/03/97 Pique et al. VT 5,635,453 02/17/98 Roeder et al. VU 5,719,417 12/07/99 5,998,819 Yokoyama et al. W **Date Considered** Examiner

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

| Form PTO 1449 | | U.S. DEPARTMENT O | F COMMERCE | ATTY DOCKET NO. | | SERIAL N | O. |
|---------------------|------|---------------------|---------------|--|------------|--------------|-------------------------------|
| (Modified) | | | 248402US99DIV | | 10/767,994 | | |
| | | | APPLICANT | | | | |
| LIST OF | REFE | RENCES CITED BY APP | LICANT | Jamal RAMDANI, et al. | | | |
| | • | | | FILING DATE | | GROUP | |
| | | | | February 2, 2004 | | 2815 | |
| | | | | U.S. PATENT DOCUMENTS | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE |
| | vw | 2002/0079576 | 06/27/02 | Seshan | | | |
| | VX | 5,148,504 | 09/15/92 | Levi et al. | | | |
| | VY | 2002/0195610 A1 | 12/26/02 | Klosowiak | | | |
| | VZ | 5,477,363 | 12/19/95 | Matsuda | | | |
| | WA | 5,905,571 | 05/18/99 | Butler et al. | | | |
| | WB | 5,570,226 | 10/29/96 | Ota | | | |
| | wc | 5,087,829 | 02/11/92 | Ishibashi et al. | | | |
| | WD | 2001/0020278 A1 | 09/06/01 | Saito | | | |
| | WE | 6,496,469 B1 | 12/17/02 | Uchizaki | | | |
| | WF | 5,679,947 | 10/21/97 | Doi et al. | | | |
| | WG | 2001/0036142 A1 | 11/01/01 | Kadowaki et al. | | | |
| | WH | 5,446,719 | 08/29/95 | Yoshida et al. | | | |
| | WI | 5,831,960 | 11/03/98 | Jiang et al. | | | |
| | WJ | 5,693,140 | 12/02/97 | McKee et al. | | | |
| | WK | 6,376,337 B1 | 04/23/02 | Wang et al. | · · | | |
| | WL | 4,177,094 | 12/04/79 | Kroon | | | |
| | WM | 5,216,359 | 06/01/93 | Makki et al. | | | |
| | WN | 6,307,996 B1 | 10/23/01 | Nashimoto et al. | | | |
| | wo | 5,371,621 | 12/06/94 | Stevens | | | |
| | WP | 2002/0145168 A1 | 10/10/02 | Bojarczuk, Jr et al. | | | |
| | WQ | 3,617,951 | 11/02/71 | Anderson | | | |
| | WR | 5,838,053 | 11/17/98 | Bevan et al. | | | |
| | ws | 5,684,302 | 11/04/97 | Wersing et al. | | | |
| | WT | 5,959,308 | 09/28/99 | Shichijo et al. | | | |
| | wυ | 5,362,972 | 11/08/94 | Yazawa et al. | | | |
| | wv | 5,864,171 | 01/26/99 | Yamamoto et al. | | | |
| | ww | 5,028,563 | 07/02/91 | Feit et al. | | | |
| | wx | 5,937,115 | 08/10/99 | Domash | | | |
| Examiner | | | | citation is in conformance with MPEP 6 | Date Co | | |

^{*}Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

| Form PTO 1449 (Modified) | | | ATTY DOCKET NO. | | SERIAL NO. | | |
|---------------------------------------|-------------|---|-----------------------------------|---|-------------|--------------|---------------------------------------|
| | | | 248402US99DIV 10/767,994 | | | | |
| LIST OF REFERENCES CITED BY APPLICANT | | APPLICANT | | - | | | |
| | | | 2.0/111 | Jamal RAMDANI, et al. | | | |
| | | | | FILING DATE | | GROUP | |
| | | | | February 2, 2004 | | 2815 | |
| | | | | U.S. PATENT DOCUMENTS | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE |
| | WY | 5,878,175 | 03/02/99 | Sonoda et al. | | | |
| | wz | 4,801,184 | 01/31/89 | Revelli | | | |
| _ | XA | 5,140,387 | 08/18/92 | Okazaki et al. | | | |
| | ХВ | 5,410,622 | 04/25/95 | Okada et al. | | | |
| | хс | 6,064,783 | 05/16/00 | Congdon et al. | | | |
| | XD | 5,772,758 | 06/30/98 | Collins et al. | | | |
| | XE | 5,666,376 | 09/09/97 | Cheng | | | |
| | XF | 5,976,953 | 11/02/99 | Zavracky et al. | | | |
| | XG | 5,578,162 | 11/26/96 | D'Asaro et al. | | | |
| | хн | 5,585,167 | 12/17/96 | Satoh et al. | | | |
| | Χi | 5,674,813 | 10/07/97 | Nakamura et al. | | | |
| | XJ | 5,574,296 | 11/12/96 | Park et al. | | | |
| | XK | 6,504,189 | 01/07/03 | Matsuda et al. | | | |
| | XL. | 5,987,196 | 11/16/99 | Noble | | | |
| | XM | | | | | | · · · · · · · · · · · · · · · · · · · |
| | XN | | | | | | |
| | хо | | | · | | | |
| | XP | | | | | | |
| | XQ | | | | | | |
| | XR | | | | | | |
| | xs | | | | | | |
| | хт | | | | | | |
| | ΧU | | | | | | |
| | χV | | | | | | |
| | xw | | | | | | |
| | XX | | | | | | |
| | XY | | | | | | |
| | XZ | | | | | | |
| Examiner | | | | Date Considered | | | |
| *Examiner: In conformance | itial if re | eference is considered, v t considered. Include co | whether or not by of this form | citation is in conformance with MPEP 60 with next communication to applicant. | 9; Draw lir | ne through | citation if not in |

SERIAL NO. ATTY DOCKET NO. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Form PTO 1449 (Modified) 10/767,994 248402US99DIV APPLICANT LIST OF REFERENCES CITED BY APPLICANT Jamal RAMDANI, et al. **GROUP** FILING DATE 2815 February 2, 2004 **FOREIGN PATENT DOCUMENTS TRANSLATION** DOCUMENT DATE COUNTRY NUMBER YES NO 09/13/00 CBC EP 1 035 759 Europe 08/26/95 **EUROPE** CBD EP 0 860 913 JAPAN W/ENGLISH ABSTRACT 5-232307 09/10/93 CBE 5-243525 09/31/93 JAPAN W/ENGLISH ABSTRACT CBF JAPAN W/ENGLISH ABSTRACT 07/25/91 CBG 3-171617 **EUROPE** 04/04/01 CBH EP 1 089 338 JAPAN (ABSTRACT) 01 294594 11/28/99 CBI 08/31/93 JAPAN (ABSTRACT) CBJ 05 221800 11/07/89 JAPAN CBK 03-149882 EUROPE 09/07/94 CBL 0 614 256 **EUROPE** СВМ 1 054 442 11/22/00 0 852 416 07/08/98 **EUROPE** CBN 01/31/02 WIPO СВО WO 02/08806 WIPO **CBP** WO 01/59837 08/16/01 JAPAN W/ENGLISH ABSTRACT 10/26/87 CBQ 62-245205 06/08/94 **EUROPE** CBR 0 600 658 EUROPE 02/06/91 0 412 002 CBS JAPAN (ENGLISH ABSTRACT) CBT 2000-349278 12/15/00 JAPAN (ENGLISH ABSTRACT) 08/08/89 CBU 01-196809 0 619 283 10/12/94 **EUROPE** CBV **EUROPE** 07/05/95 CBW 0 661 561 **EUROPE** CBX 0 331 338 09/06/89 **CBY** CBZ CCA CCB CCC CCD CCE CCF CCG CCH CCI CCJ CCK CCL CCM CCN cco CCP

| Form PTO 1449 | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | | |
|---|---|---|--|--|--|--|--|
| (Modified) | PATENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | | |
| | | APPLICANT | | | | | |
| LIST OF REF | ERENCES CITED BY APPLICANT | Jamal RAMDANI, et al. | | | | | |
| | | FILING DATE | GROUP | | | | |
| | | February 2, 2004 | 2815 | | | | |
| | OTHER REFERENCES (| Including Author, Title, Date, Pertinen | t Pages, etc.) | | | | |
| | Charles Kittel; "Introduction to | Solid State Physics"; John Wiley & | Sons, Inc. Fifth Edition; pp. 415 | | | | |
| KKA | 0 | | | | | | |
| кка | KKAP Chyuan-Wei Chen et al; "Liquid-phase epitaxial growth and characterization of InGaAsP layers grown on GaAs substrates for application to orange light-emitting diodes"; 931 Journal of Applied Physics; 77 (1995) 15 January, No. 2; Woodbury, NY, US; pp. 905-909 | | | | | | |
| кка | W. Zhu et al.; Oriented diamond September, No. 12, Woodbury, NY, | | 320 Applied Physics Letters; 63(1993) | | | | |
| кка | M. Schreck et al.; "Diamond/Ir/SrTi03: A material combination for improved heteroepitaxial diamond films" KKAR Applied Physics Letters; Vol. 74, No. 5; February 1, 1999; pp. 650-652 | | | | | | |
| кка | Yoshihiro Yokota et al.; "Cathodo S Diamond and Related Materials 8() | | pitaxial diamond films on platinum"; | | | | |
| кка | J.R. Busch et al.; "LINEAR ELECT T 13th August 1992; Vol. 28, No. 17 | | ANAR WAVEGUIDE"; Electronics Letters; | | | | |
| кка | R. Droopad et al; "Epitaxial Oxide Films on Silicon: Growth, Modeling and Device Properties"; Mat. Res. Soc. Symp. Proc. Vol. 619; 2000 Materials Research Society; pp. 155-165 | | | | | | |
| KKA | | | ms by Lateral Epitaxy Verified with RHEED Tsukuba, August 26-28 (1992); pp. 457-459 | | | | |
| KKA | Lin Li: "Ferroelectric/Supercond V 153-181 | luctor Heterostructures"; Materials | Science and Engineering: 29 (2000) pp. | | | | |
| KKA | | ritching of Vertical-Cavity Surface- chnology Letters; Vol. 9, No. 4; Ap. | Emitting Lasers with Integrated Optical ril 4, 1997; pp. 505-507 | | | | |
| KKA | Y. Q. Xu. et al.; "(Mn, Sb) drop 88, No. 2; 15 July 2000; pp. 1004 | | rrays"; Journal of Applied Physics; Vol. | | | | |
| KKA | | f dislocations in InGaAs layer on G 5 (1991) pp. 174-179; December 1991 | aAs using epitaxial lateral overgrowth"; | | | | |
| LLA | | | | | | | |
| LLAE | | | | | | | |
| LLAC | | | | | | | |
| LLAD | | | | | | | |
| LLAE | | | | | | | |
| Examiner | | | Date Considered | | | | |
| *Examiner: Initial if conformance and n | reference is considered, whether or not ot considered. Include copy of this form | citation is in conformance with MPEP 60 with next communication to applicant. | 09; Draw line through citation if not in | | | | |

PARTMENT OF COMMERCE TAND TRADEMARK OFFICE

ATTY DOCKET NO.

248402US99DIV

APPLICANT

SERIAL NO.

10/767,994

| Form PTO 1449 | | U.S. DEPARTMENT | OF COMMERCE | ATTY DOCKET NO. 7 | ⁽ τ _O | SERIAL N | 0. |
|---------------------------------------|-----------------------------|---------------------|--------------|-----------------------|-----------------------------|--------------|-------------------------------|
| (Modified) | PATENT AND TRADEMARK OFFICE | | EMARK OFFICE | 248402US99DIV | | 10/767,9 | 94 |
| | | | APPLICANT | | | | |
| LIST OF | REFE | RENCES CITED BY APP | PLICANT | Jamal RAMDANI, et al. | | | |
| | • | | | FILING DATE | | GROUP | |
| | | | | February 2, 2004 | | 2815 | |
| | | | | U.S. PATENT DOCUMENTS | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE |
| | XN | 6,233,435 B1 | 05/15/01 | WONG | | | |
| | хо | 4,723,321 | 02/02/88 | SALEH | | <u> </u> | |
| | XP | 6,181,920 B1 | 01/30/01 | DENT ET AL | | | |
| | XQ | 6,415,140 B1 | 07/02/02 | BENJAMIN ET AL | | | |
| , #1 | XR | 5,760,740 | 06/02/98 | BLODGETT | | | |
| · · · · · · · · · · · · · · · · · · · | XS | 5,238,877 | 08/24/93 | RUSSELL | | | |
| | XT | 4,876,218 | 10/24/89 | PESSA ET AL | | | |
| <u> </u> | ΧU | 6,232,242 B1 | 05/15/01 | HATA ET AL | | | |
| | χV | 4,378,259 | 03/29/83 | HASEGAWA ET AL | | | |
| | xw | 6,278,541 B1 | 08/21/01 | BAKER | | | |
| | XY | 4,298,247 | 11/03/81 | MICHELET ET AL | | | |
| | XZ · | 4,174,504 | 11/13/79 | CHENAUSKY ET AL | | <u> </u> | |
| | YA | 3,758,199 | 09/11/73 | THAXTER | | | |
| | YB | 6,362,558 B1 | 03/26/02 | FUKUI | | | |
| | YC | 6,140,746 | 10/31/00 | MIYASHITA ET AL | | | |
| | YD | 2002/0076878 A1 | 06/20/02 | WASA ET AL | ļ | | |
| | YE | 6,419,849 B1 | 07/16/02 | QIU ET AL | | | |
| | YF | 2002/0179000 A1 | 12/05/02 | LEE ET AL | | | · |
| | YG | 6,341,851 | 01/29/02 | TAKAYAMA ET AL | <u> </u> | | |
| | YH | 2001/0055820 A1 | 12/27/01 | SAKURAI ET AL | <u> </u> | | |
| | YI | 6,204,525 B1 | 03/20/01 | SAKURAI ET AL | | | |
| | YJ | 5,985,404 | 11/16/99 | YANO ET AL | | | |
| | ΥK | 6,538,359 B1 | 03/25/03 | HIRAKU ET AL | | | |
| | YL | 6,498,358 B1 | 12/24/02 | LACH ET AL | | | |
| | YM | 5,387,811 | 02/07/95 | SAIGOH | | | |
| | YN | 5,523,602 | 06/04/96 | HORIUCHI ET AL | | | |
| | YO | 5,362,998 | 11/08/94 | IWAMURA ET AL | | | |
| | ΥP | 5,188,976 | 02/23/93 | KUME ET AL | <u> </u> | | |
| | | | | | | | |

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Examiner

Date Considered

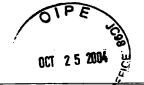
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY DOCKET NO. SERIAL NO. Form PTO 1449 (Modified) 248402US99DIV 10/767,994 **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Jamal RAMDANI, et al. **FILING DATE GROUP** February 2, 2004 2815 **U.S. PATENT DOCUMENTS** EXAMINER DOCUMENT SUB **FILING DATE** DATE NAME **CLASS** NUMBER INITIAL CLASS IF APPROPRIATE YQ 6,501,121 B1 12/31/02 YU ET AL YR 5,919,515 07/06/99 YANO ET AL YS 5,238,877 08/24/93 RUSSELL YT 5,540,785 07/30/96 **DENNARD ET AL** ΥU 5,997,638 12/07/99 **COPEL ET AL** 6,291,866 09/18/01 WALLACE YV 5,365,477 11/15/94 COOPER, JR ET AL YW YX 5,548,141 08/20/96 MORRIS ET AL YY 2002/0021855 02/21/02 KIM ΥU YZ 6,110,840 08/29/00 ZA 5,667,586 09/16/97 **EK ET AL** 05/17/94 FRIEDERICH ET AL ZΒ 5,313,058 05/24/94 HUNT ET AL ZC 5,315,128 07/06/99 ZD 5,919,522 **BAUM ET AL** ZΕ 4,843,609 06/27/89 OHYA ET AL ZF 4,626,878 12/02/86 **KUWANO ET AL** ZG 4,525,871 06/25/85 FOYT ET AL ZH 3,818,451 06/18/74 **COLEMAN** ΖI 6,059,895 05/09/00 CHU ET AL 05/08/84 KING ET AL ZJ 4,447,116 ZK 6,022,671 02/08/00 **BINKLEY ET AL** ZL 5,754,714 05/19/98 SUZUKI ET AL ZΜ 6,524,651 B2 02/25/03 **GAN ET AL** ΖN 6,355,945 B1 03/12/03 KADOTA ET AL ZO 5,642,371 06/24/97 **TOHYAMA ET AL** 6,445,724 B2 09/03/02 **ABELES** 7P ZQ 5,753,934 05/19/98 YANO ET AL ZR 6,326,667 B1 12/04/01 SUGIYAMA ET AL 04/18/00 **7**S 6,051,874 **MASUDA** ZT 5,166,761 11/24/92 **OLSON ET AL** ΖU 5,574,744 11/12/96 **GAW ET AL** Examiner **Date Considered** *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in

conformance and not considered. Include copy of this form with next communication to applicant.

() (1) (2)

ATTY DOCKET NO. SERIAL NO. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Form PTO 1449 (Modified) 10/767,994 248402US99DIV **APPLICANT** LIST OF REFERENCES CITED BY APPLICANT Jamai RAMDANI, et al. **GROUP** FILING DATE 2815 February 2, 2004 **FOREIGN PATENT DOCUMENTS TRANSLATION** DOCUMENT DATE COUNTRY NUMBER YES NO JAPAN W/ENGLISH ABSTRACT 09/17/93 CCA | 5-238894 ссв I 2 152 315 07/31/85 **GREAT BRITAIN** 07/19/01 JAPAN W/ENGLISH ABSTRACT CCC 2001-196892 JAPAN (ENGLISH ABSTRACT) 10/06/00 CCD 2000-278085 **WIPO** CCE WO 03/012874 02/13/03 CCF 1 043 427 10/11/00 **EUROPE** 01/17/01 **EUROPE** CCG 1 069 605 12/12/02 **WIPO** CCH WO 02/099885 CCI 10-269842 10/09/98 JAPAN W/ENGLISH ABSTRACT 04/14/84 JAPAN (ENGLISH ABSTRACT) CCJ 59066183 02/27/91 JAPAN (ENGLISH ABSTRACT) CCK 03046384 02/07/02 WIPO CCL WO 02/11254 CCM 0 494 514 07/15/92 **EUROPE** CCN 0 247 722 12/02/87 **EUROPE** 09/20/00 **EUROPE** cco 1 037 272 JAPAN (ENGLISH ABSTRACT) CCP 59-073498 04/25/84 60-161635 08/23/85 JAPAN W/ENGLISH ABSTRACT ccal JAPAN W/ENGLISH ABSTRACT 59-044004 03/12/84 CCR 10/17/90 **EUROPE** ccs 0 392 714 CCT CCU CCV CCW CCX CCY CCZ CDA CDB CDC CDD CDE CDF CDG CDH CDI CDJ CDK CDL CDM CDN

| Form PTO 1449 | U.S. DEPARTMENT OF COMMERCE | ATTY DOCKET NO. | SERIAL NO. | | | | | |
|---------------|--|---|--|--|--|--|--|--|
| (Modified) | PATENT AND TRADEMARK OFFICE | 248402US99DIV | 10/767,994 | | | | | |
| | | APPLICANT | | | | | | |
| LIST OF REFE | RENCES CITED BY APPLICANT | Jamal RAMDANI, et al. | | | | | | |
| | | FILING DATE | GROUP | | | | | |
| | | February 2, 2004 | 2815 | | | | | |
| | | Including Author, Title, Date, Pertinen | | | | | | |
| LLA | | oked on silicon"; Science News Online; S | Sept. 15, 2001; pp. 1-3 | | | | | |
| LLAE | 3 | Motorola Develops New Super-Fast Chip"; USA Today; Sept. 4, 2001 | | | | | | |
| LLAC | | n Si Wafer"; AsiaBizTech; Nov. 2001pp. 1 | | | | | | |
| LLAC | | eld GaAs Breakthrough"; Micromagazine | .com (no date available); pp. 1-3 | | | | | |
| LLAE | Jong-Gul YOON; "Growth of Ferroelectric LiNbO3 Thin Film on MgO-Buffered Si by the Sol-Gel Method"; Journal of Korean Physical Society (Proc. Suppl.); Vol. 29, Nov. 1996; pp. S648-S651 | | | | | | | |
| LLAF | V. Bornand et al.; "Deposition of LiTaO3 thin films by pyrosol process"; Thin Solid Films 304 (1997); pp.239-244 LLAF | | | | | | | |
| LLAC | R. Droopad et al.; "Development of high dielectric constant epitaxial oxides on silicon by molecular beam epitaxy"; Materials Science and Engineering B87 (2001); pp.292-296 | | | | | | | |
| LLAF | A.K. Sharma et al.; "Integration of Pb(Zr0.52Ti0.48)O3 epilayers with Si by domain epitaxy"; Applied Physics Letters, Vol. 76, No. 11; March 13, 2000; pp. 1458-1460 | | | | | | | |
| LLA | . l | y GaAs-AlGaAs HBT's by MBE with Be E 2(1991) September, No. 9, New York, U | Base Doping and InGaAs Emitter Contacts"; S | | | | | |
| LLA | 1 | duced stress tuning of electro-optic device | ces"; 320 Applied Physics Letters; 59(1991) 30 | | | | | |
| LLAF | J. Piprek; "Heat Flow Analysis of Lor Science, Newark, DE, 19716-3106; (| g-Wvelength VCSELs with Various DBR Oct. 31, 1994; pp. 286-287 | Materials"; University of Delaware, Materials | | | | | |
| LLAL | | of designing an efficient nitride VCSEL re | esonator"; J. Phys. D: Appl. Phys. 34(2001); | | | | | |
| LLAN | 1 | aAs IC Manufacturer's Perspective"; Ga | As IC Symposium, IEEE, 1988; pp. 243-246 | | | | | |
| LLAN | Y. Kitano et al.; "Thin film crystal growth of BaZrO3 at low oxygen partial pressure"; Journal of Crystal Growth 243 (2002) pp. 164-169 | | | | | | | |
| LLAC | M.E. Hawley; et al; "Microstructural Study of Colossal Magneto-Resistive Films As a Function of Growth Temperature, As Deposited and Annealed"; 401, 1996; pp. 531-536 | | | | | | | |
| LLAF | , | | | | | | | |
| LLAC | | | | | | | | |
| Examiner | | | Date Considered | | | | | |
| | reference is considered, whether or no | t citation is in conformance with MPEP 6 | 09; Draw line through citation if not in | | | | | |



SHEET 1 OF 1

| Form PTO 1449 | | U.S. DEPARTMENT | OF COMMERCE | ATTY DOCKET NO. | *r | SERIAL N | O. |
|--|--|---|--------------|-----------------------|-----------------|---------------|-------------------------------|
| (Modified) | | PATENT AND TRAC | EMARK OFFICE | 248402US99DIV | | 10/767,9 | 94 |
| | | | | APPLICANT | | | |
| LIST OF | REFE | RENCES CITED BY AP | PLICANT | Jamal RAMDANI, et al. | | | |
| | | | | FILING DATE | | GROUP | |
| | | | | February 2, 2004 | | 2815 | |
| U.S. PATENT DOCUMENTS | | | | | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE |
| | zv | 5,122,679 | 06/16/92 | ISHII ET AL | | | |
| | zw | 6,232,806 | 05/15/01 | WOESTE ET AL | | | |
| | ZX | 5,430,397 | 07/04/95 | ITOH ET AL | | | |
| | ZY | 6,151,240 | 11/21/00 | SUZUKI | | | |
| | ZZ | 6,528,374 | 03/04/03 | BOJARCZUK, JR ET AL | | | |
| | A1 | 6,589,887 | 07/08/03 | DALTON ET AL | | | |
| | A2 | 5,064,781 | 11/12/91 | CAMBOU ET AL | | | |
| | А3 | 2002/0052061 | 05/02/02 | FITZGERALD | | | |
| | A4 | 5,696,392 | 12/09/97 | CHAR ET AL | | | |
| - | A5 | 5,986,301 | 11/16/99 | FUKUSHIMA ET AL | | | |
| | A6 | 6,329,277 | 12/11/01 | LIU ET AL | | | |
| | A7 | | | | | | |
| | A8 | | | | | | |
| | A9 | | | | | | |
| FOREIGN PATENT DOCUMENTS | | | | | | | |
| | DOCUMENT DATE COUNTS | | | | TRANSLATION | | |
| | | NUMBER | DATE | COUNTRY | | YES NO | |
| | ccs | WO 99/67882 | 12/29/99 | WIPO | | | |
| | ССТ | WO 95/02904 | 01/26/95 | WIPO | | | |
| | CCU | WO 02/009150 | 01/31/02 | WIPO | | | |
| <u> </u> | ccv | 0 766 292 | 04/02/97 | EUROPE | | | |
| | ccw | 198 29 609 | 01/05/00 | GERMANY | | | |
| | ссх | | 01/17/01 | EUROPE | | | |
| | CCY | 0 828 287 | 03/11/98 | EUROPE | | | |
| | CCZ | 1 176 230 | 01/30/02 | EUROPE | | • | |
| OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) | | | | | | | |
| | YI W. et al; "Mechanism of cleaning Si (100) surface using Sr and SrO for the growth of crystalline SrTiO/sub 2/films" Journal of Vacuum Science & Technology, Vol. 20, No. 4, July 2002 (2002-07) pp. 1402-1405 | | | | | | |
| | LLAQ | XIAMING HU et al; "Sr/Si template formation for the epitaxial growth of SrTiO/sub 3/on silicon" Materials Research Society Proceedings, Vol. 716, 2002, pp. 261-266 | | | | | |
| | LLAR | | | | | | |
| | | | | | <u> </u> | | |
| | LLAS | | | | Addi | tional Refere | ences sheet(s) attached |
| Examiner | | | • | | Date Considered | | |
| *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | | | | | | | |